

Memory FeRAM

2 M (256 K × 8) Bit SPI

MB85RS2MTA

■ DESCRIPTION

MB85RS2MTA is a FeRAM (Ferroelectric Random Access Memory) chip in a configuration of 262,144 words × 8 bits, using the ferroelectric process and silicon gate CMOS process technologies for forming the nonvolatile memory cells.

MB85RS2MTA adopts the Serial Peripheral Interface (SPI).

The MB85RS2MTA is able to retain data without using a back-up battery, as is needed for SRAM.

The memory cells used in the MB85RS2MTA can be used for 10^{13} read/write operations, which is a significant improvement over the number of read and write operations supported by Flash memory and E²PROM.

MB85RS2MTA does not take long time to write data like Flash memories or E²PROM, and MB85RS2MTA takes no wait time.

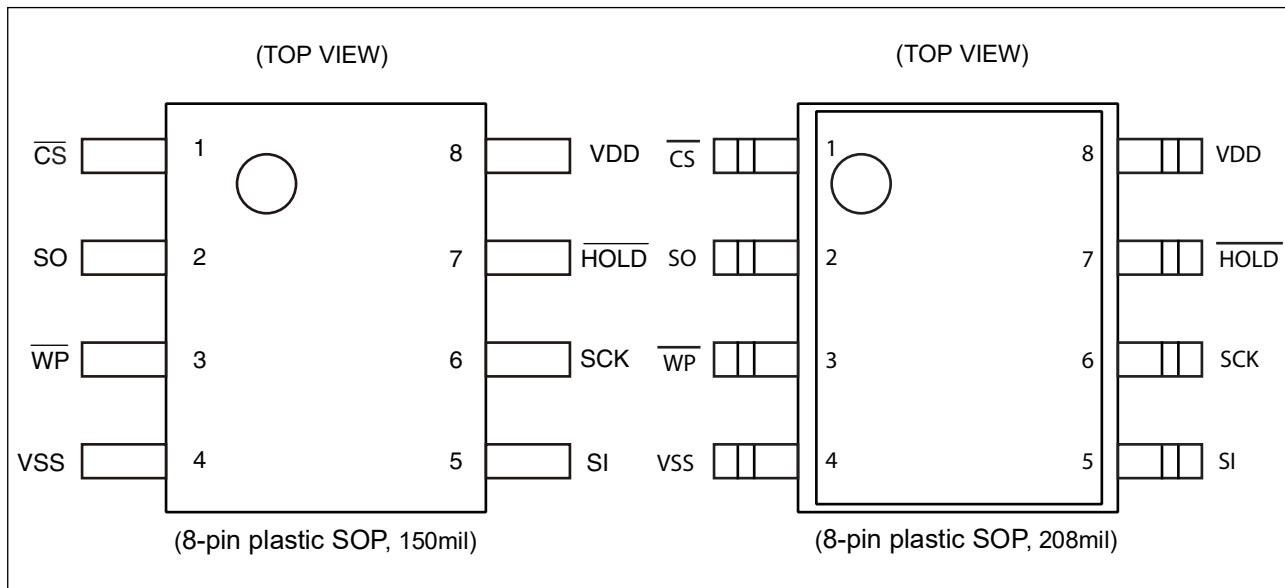
■ FEATURES

- Bit configuration : 262,144 words × 8 bits
- Serial Peripheral Interface : SPI (Serial Peripheral Interface)
 - Correspondent to SPI mode 0 (0, 0) and mode 3 (1, 1)
- Operating frequency : 40MHz (Max)
- High endurance : 10^{13} times / byte
- Data retention : 10 years (+85 °C), 95 years(+55 °C)
- Operating power supply voltage : 1.7 V to 3.6 V
- Low power consumption :
 - Operating power supply current 2.3mA (Max@40 MHz)
 - Standby current 50 μ A (Max)
 - Sleep current 10 μ A (Max)
- Operation ambient temperature range : -40 °C to +85 °C
- Package : 8-pin plastic SOP
 - RoHS compliant

Fujitsu Semiconductor Memory Solutions Limited has changed its name to RAMXEED Limited. RAMXEED Limited will continue to offer and support existing products while maintaining Fujitsu's part number unchanged.

MB85RS2MTA

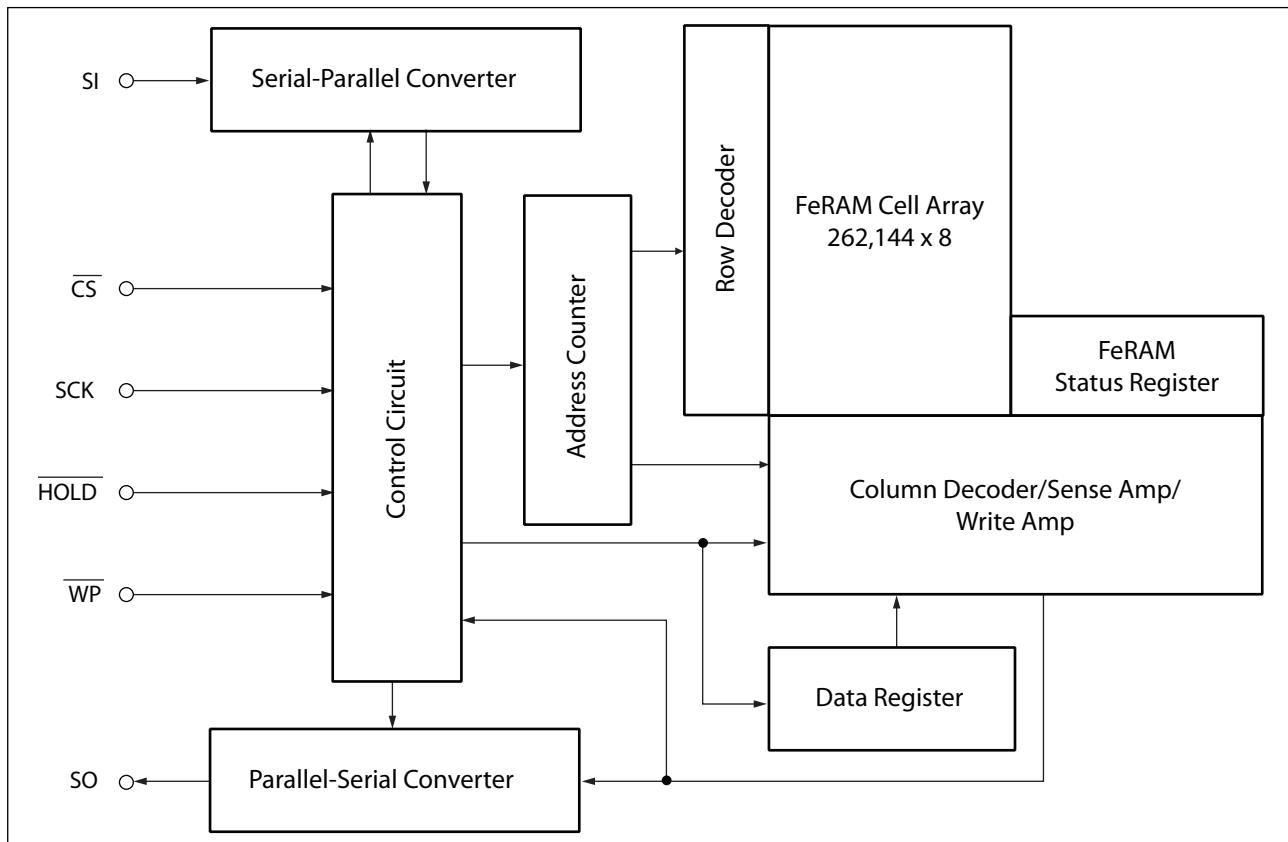
■ PIN ASSIGNMENT



■ PIN FUNCTIONAL DESCRIPTIONS

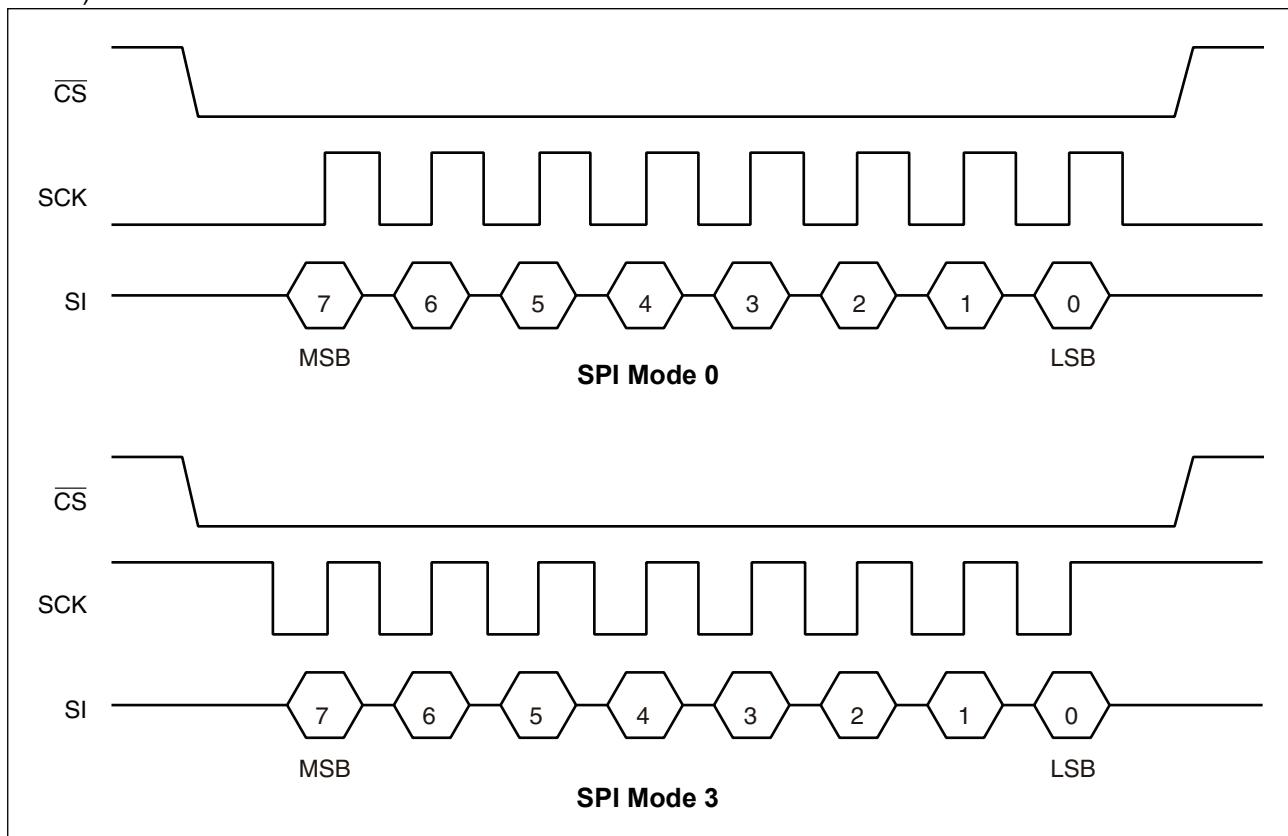
Pin No.	Pin Name	Functional description
1	\overline{CS}	Chip Select pin This is an input pin to make chips select. When \overline{CS} is "H" level, device is in deselect (standby) status and SO becomes High-Z. Inputs from other pins are ignored for this time. When CS is "L" level, device is in select (active) status. \overline{CS} has to be "L" level before inputting op-code. The Chip Select pin is pulled up internally to the VDD pin.
3	\overline{WP}	Write Protect pin This is a pin to control writing to a status register. The writing of status register (see "■ STATUS REGISTER") is protected in related with \overline{WP} and WPEN. See "■WRITING PROTECT" for detail.
7	\overline{HOLD}	Hold pin This pin is used to interrupt serial input/output without making chips deselect. When HOLD is "L" level, hold operation is activated, SO becomes High-Z, SCK and SI become do not care. See "■HOLD OPERATION" for detail.
6	SCK	Serial Clock pin This is a clock input pin to input/output serial data. SI is loaded synchronously to a rising edge, SO is output synchronously to a falling edge.
5	SI	Serial Data Input pin This is an input pin of serial data. This inputs op-code, address, and writing data.
2	SO	Serial Data Output pin This is an output pin of serial data. Reading data of FeRAM memory cell array and status register data are output. This is High-Z during standby.
8	VDD	Supply Voltage pin
4	VSS	Ground pin

■ BLOCK DIAGRAM



■ SPI MODE

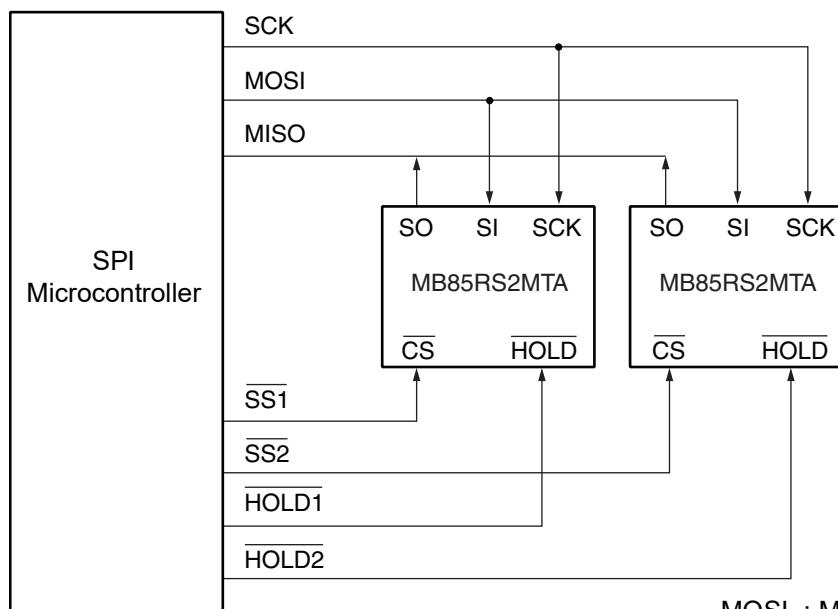
MB85RS2MTA corresponds to the SPI mode 0 (CPOL = 0, CPHA = 0) , and SPI mode 3 (CPOL = 1, CPHA = 1) .



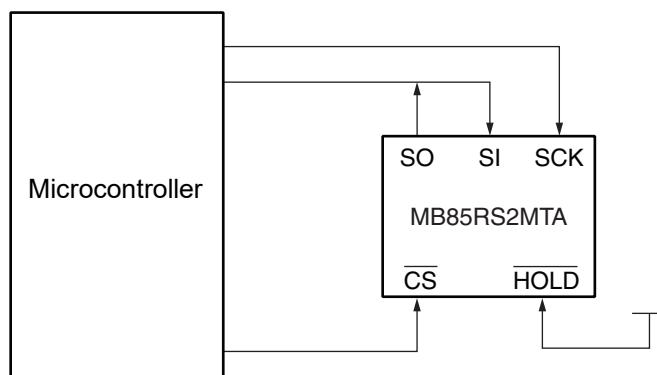
MB85RS2MTA

■ SERIAL PERIPHERAL INTERFACE (SPI)

MB85RS2MTA works as a slave of SPI. More than 2 devices can be connected by using microcontroller equipped with SPI port. By using a microcontroller not equipped with SPI port, SI and SO can be bus connected to use.



System Configuration with SPI Port



System Configuration without SPI Port

■ STATUS REGISTER

Bit No.	Bit Name	Function
7	WPEN	Status Register Write Protect This is a bit composed of nonvolatile memories (FeRAM). WPEN protects writing to a status register (refer to "■WRITING PROTECT") relating with WP input. Writing with the WRSR command and reading with the RDSR command are possible.
6 to 4	—	Not Used Bits These are bits composed of nonvolatile memories, writing with the WRSR command is possible. These bits are not used but they are read with the RDSR command.
3	BP1	Block Protect
2	BP0	This is a bit composed of nonvolatile memory. This defines size of write protect block for the WRITE command (refer to "■BLOCK PROTECT"). Writing with the WRSR command and reading with the RDSR command are possible.
1	WEL	Write Enable Latch This indicates FeRAM Array and status register are writable. The WREN command is for setting, and the WRDI command is for resetting. With the RDSR command, reading is possible but writing is not possible with the WRSR command. WEL is reset after the following operations. After power ON. After WRDI command recognition. After return from "SLEEP mode" mode. This device supports continual programming mode. After the following operations, without resetting WEL, this device can be programmed continually. After WRSR command. After WRITE command.
0	0	This is a bit fixed to "0".

■ OP-CODE

MB85RS2MTA accepts 9 kinds of command specified in op-code. Op-code is a code composed of 8 bits shown in the table below. Do not input invalid codes other than those codes. If CS is risen while inputting op-code, the command are not performed.

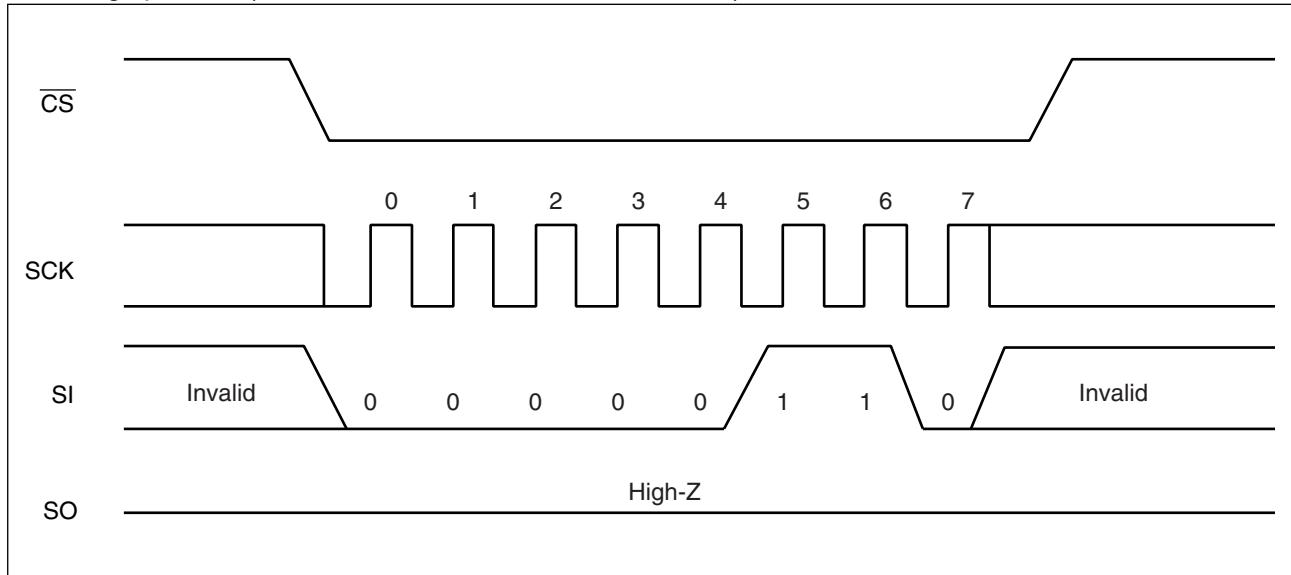
Name	Description	Op-code
WREN	Set Write Enable Latch	0000 0110 _B
WRDI	Reset Write Enable Latch	0000 0100 _B
RDSR	Read Status Register	0000 0101 _B
WRSR	Write Status Register	0000 0001 _B
READ	Read Memory Code	0000 0011 _B
WRITE	Write Memory Code	0000 0010 _B
RDID	Read Device ID	1001 1111 _B
FSTRD	Fast Read Memory Code	0000 1011 _B
SLEEP	Sleep Mode	1011 1001 _B

MB85RS2MTA

■ COMMAND

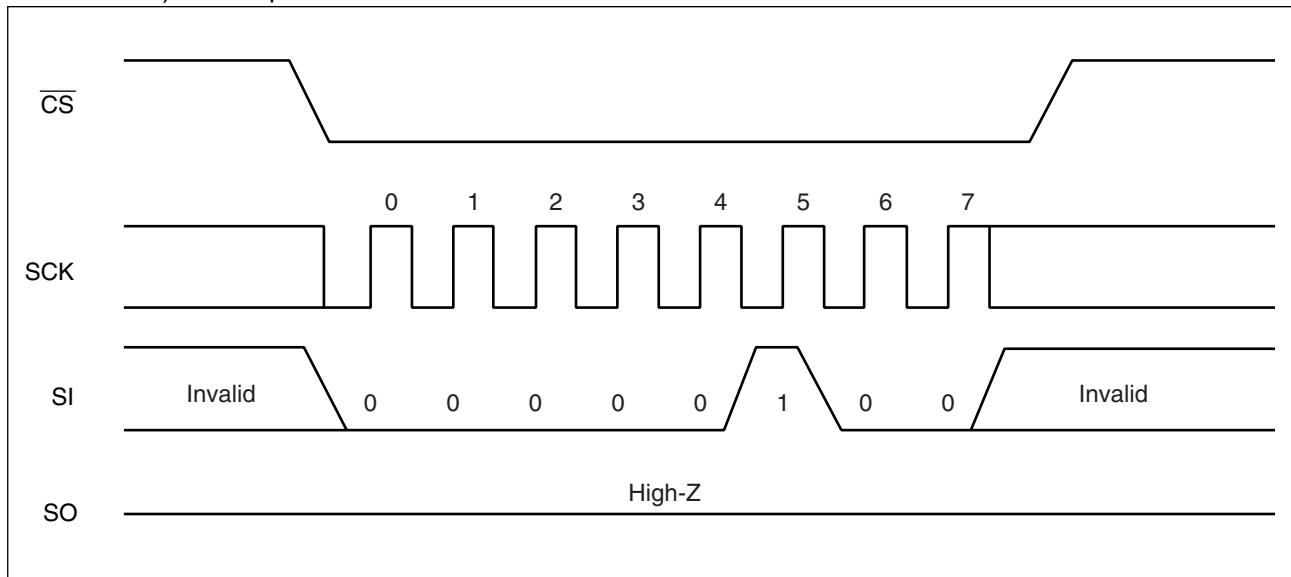
• WREN

The WREN command sets WEL (Write Enable Latch) . WEL has to be set with the WREN command before writing operation (WRSR command and WRITE command) .



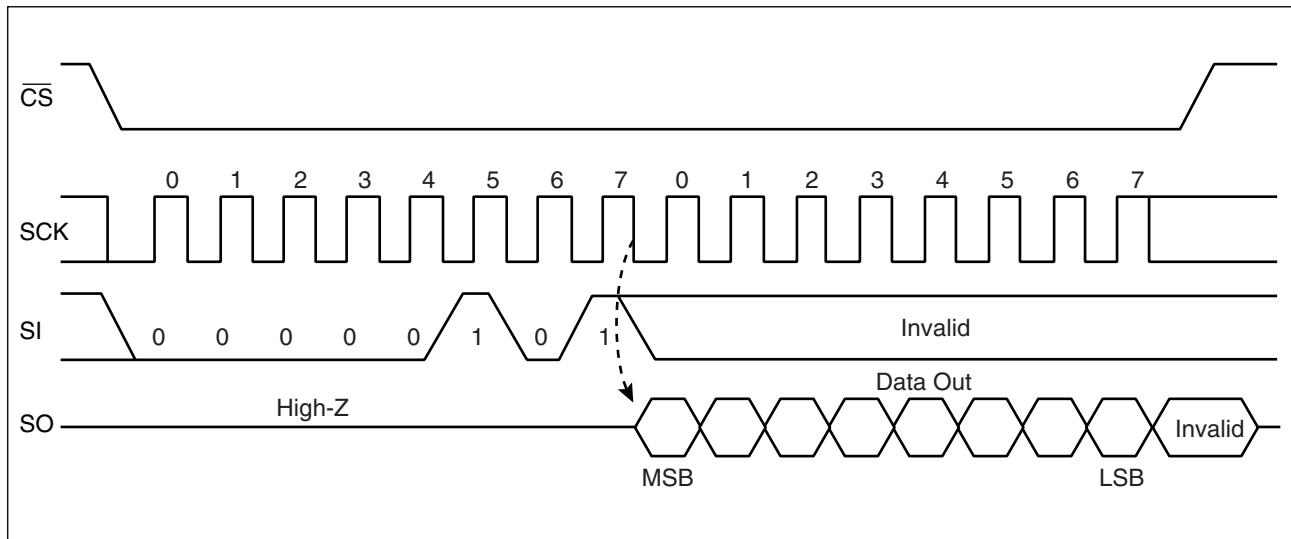
• WRDI

The WRDI command resets WEL (Write Enable Latch) . Writing operation (WRSR command and WRITE command) are not performed when WEL is reset.



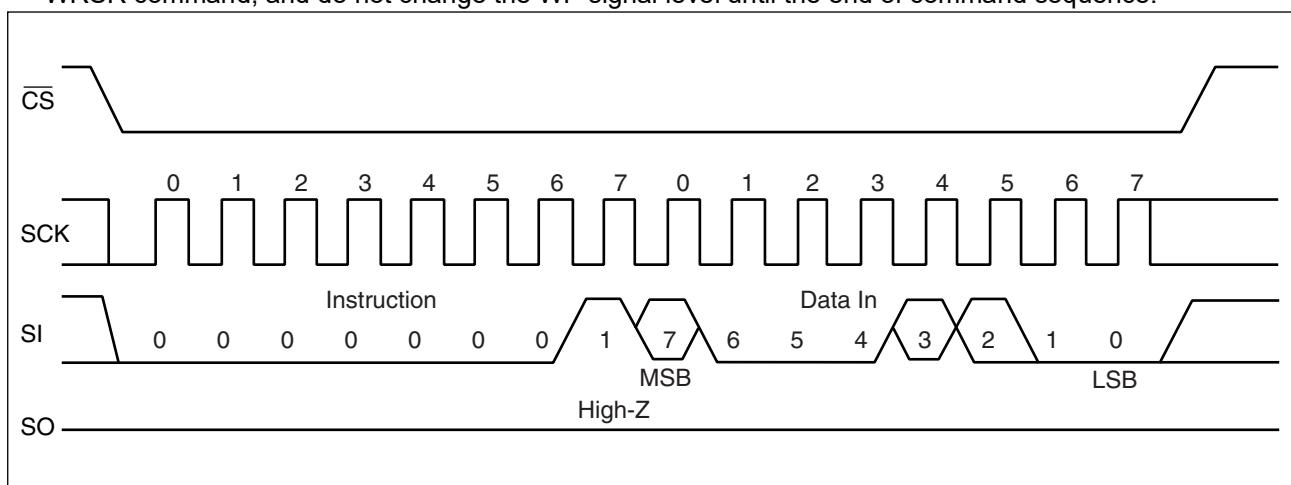
- **RDSR**

The RDSR command reads status register data. After op-code of RDSR is input to SI, 8-cycle clock is input to SCK. The SI value is invalid for this time. SO is output synchronously to a falling edge of SCK. In the RDSR command, repeated reading of status register is enabled by sending SCK continuously before rising of CS.



- **WRSR**

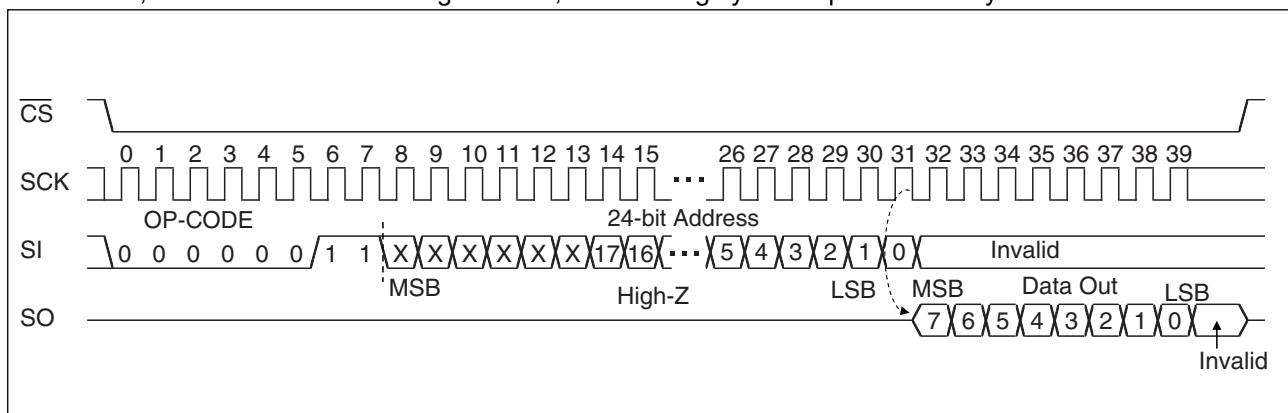
The WRSR command writes data to the nonvolatile memory bit of status register. After performing WRSR op-code to a SI pin, 8 bits writing data is input. WEL (Write Enable Latch) is not able to be written with WRSR command. A SI value correspondent to bit 1 is ignored. Bit 0 of the status register is fixed to “0” and cannot be written. The SI value corresponding to bit 0 is ignored. WP signal level shall be fixed before performing WRSR command, and do not change the WP signal level until the end of command sequence.



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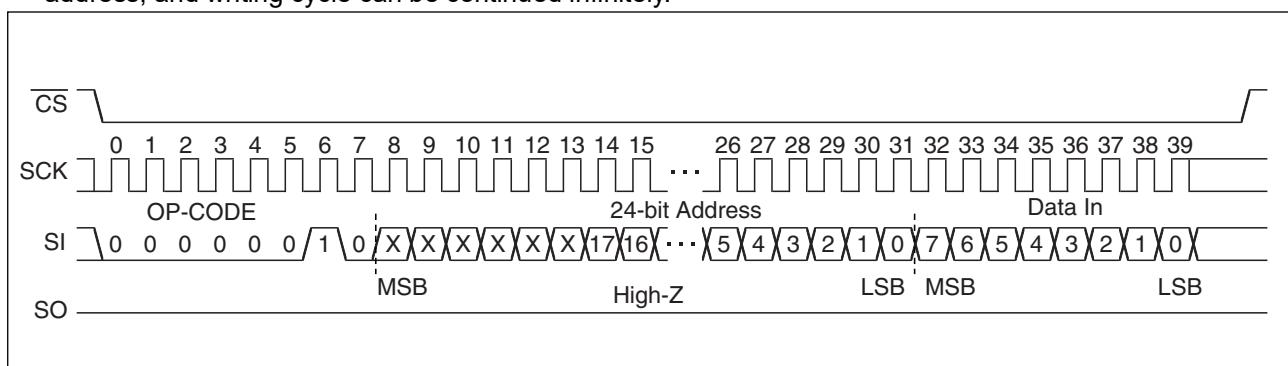
• READ

The READ command reads FeRAM memory cell array data. Arbitrary 24 bits address and op-code of READ are input to SI. The 6-bit upper address bit is invalid. Then, 8-cycle clock is input to SCK. SO is output synchronously to the falling edge of SCK. While reading, the SI value is invalid. When CS is risen, the READ command is completed, but keeps on reading with automatic address increment which is enabled by continuously sending clocks to SCK in unit of 8 cycles before CS rising. When it reaches the most significant address, it rolls over to the starting address, and reading cycle keeps on infinitely.



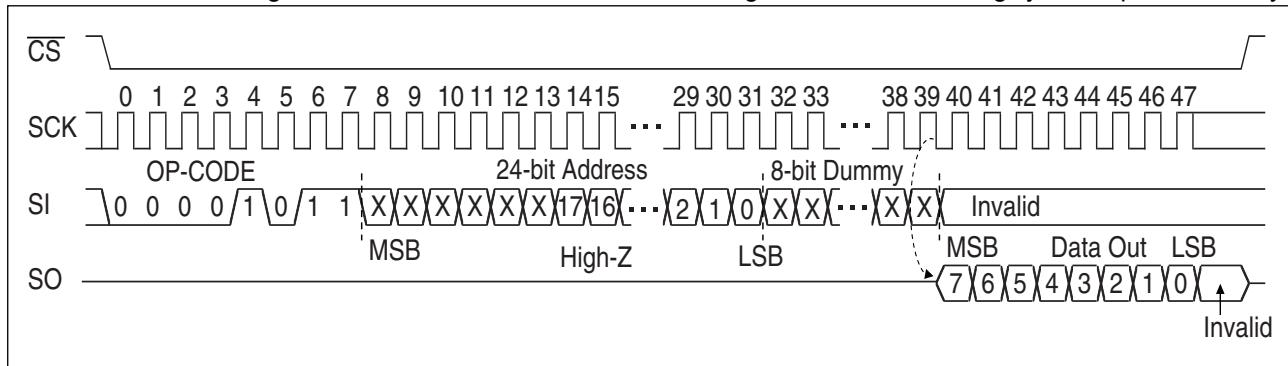
• WRITE

The WRITE command writes data to FeRAM memory cell array. WRITE op-code, arbitrary 24 bits of address and 8 bits of writing data are input to SI. The 6-bit upper address bit is invalid. When 8 bits of writing data is input, data is written to FeRAM memory cell array. Risen CS will terminate the WRITE command, but if you continue sending the writing data for 8 bits each before CS rising, it is possible to continue writing with automatic address increment. When it reaches the most significant address, it rolls over to the starting address, and writing cycle can be continued infinitely.



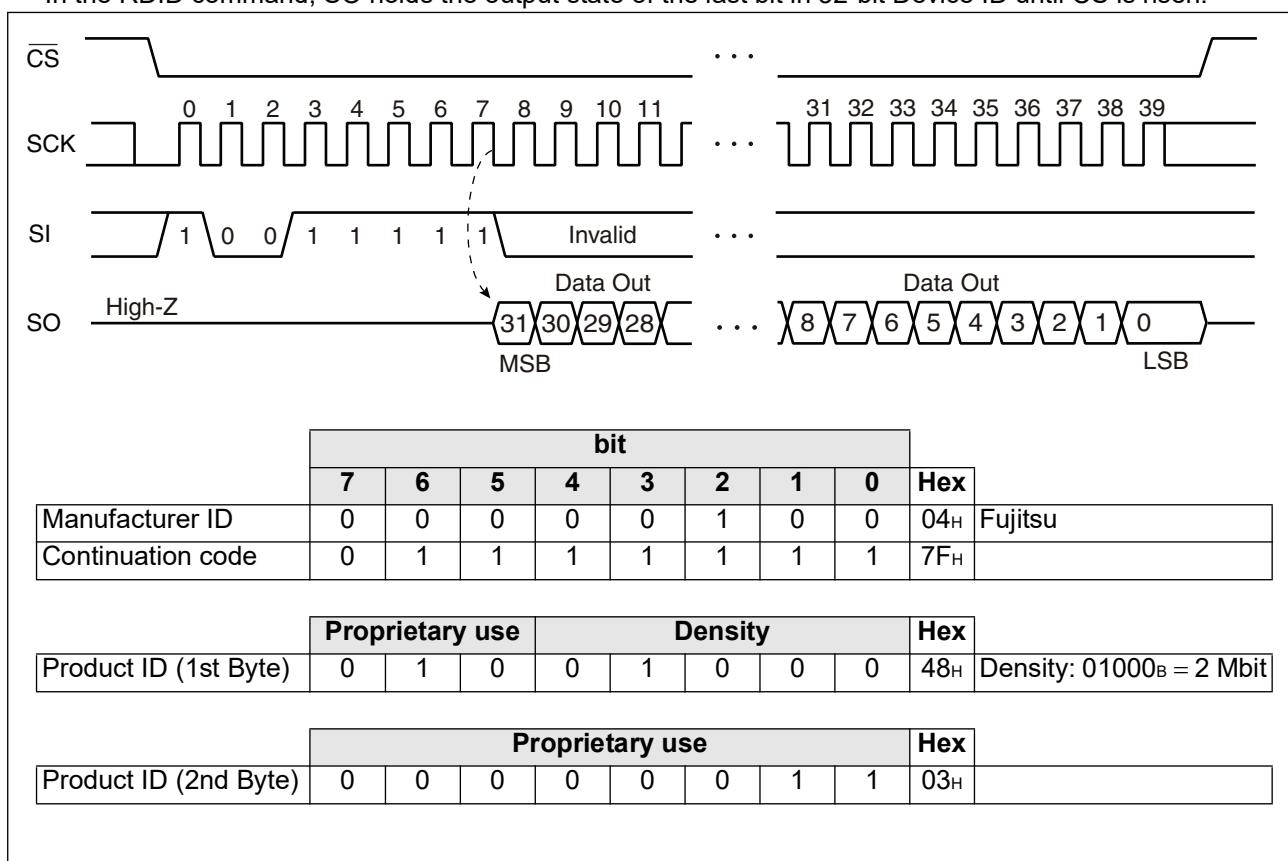
• FSTRD

The FSTRD command reads FeRAM memory cell array data. Arbitrary 24 bits address and op-code of FSTRD are input to SI followed by 8 bits dummy. The 6-bit upper address bit is invalid. Then, 8-cycle clock is input to SCK. SO is output synchronously to the falling edge of SCK. While reading, the SI value is invalid. When CS is risen, the FSTRD command is completed, but keeps on reading with automatic address increment which is enabled by continuously sending clocks to SCK in unit of 8 cycles before CS rising. When it reaches the most significant address, it rolls over to the starting address, and reading cycle keeps on infinitely.



• RDID

The RDID command reads fixed Device ID. After performing RDID op-code to SI, 32-cycle clock is input to SCK. The SI value is invalid for this time. SO is output synchronously to a falling edge of SCK. The output is in order of Manufacturer ID (8bit)/Continuation code (8bit)/Product ID (1st Byte)/Product ID (2nd Byte). In the RDID command, SO holds the output state of the last bit in 32-bit Device ID until CS is risen.

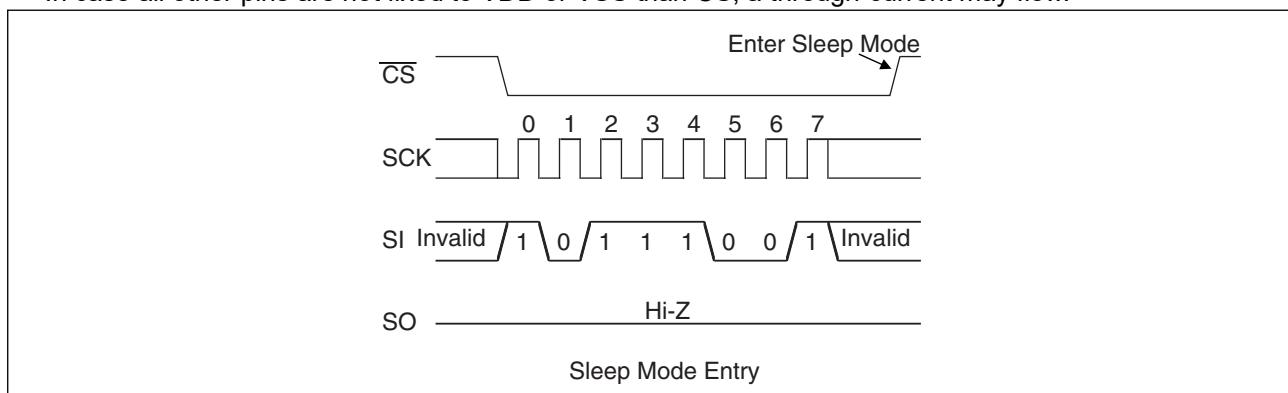


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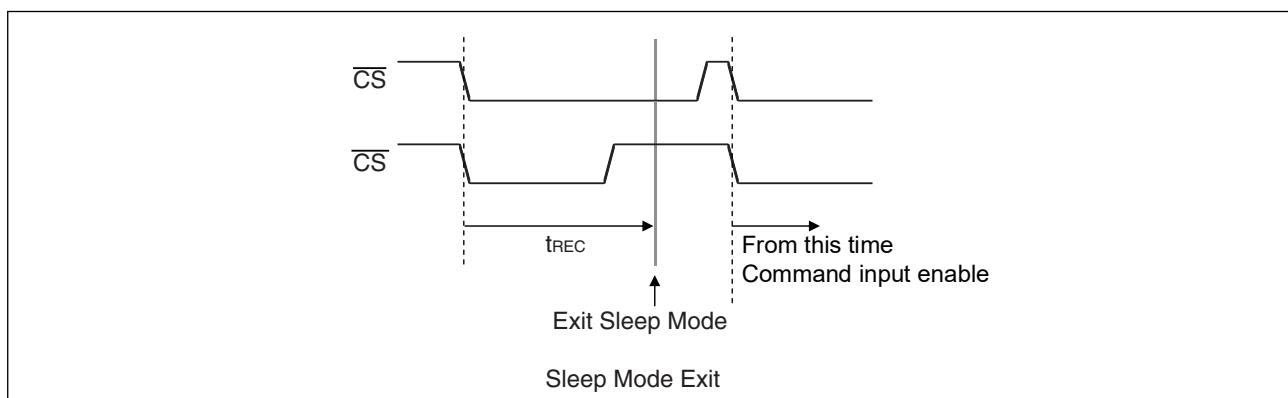
• SLEEP

The SLEEP command shifts the LSI to a low power mode called “SLEEP mode”. The transition to the SLEEP mode is carried out at the rising edge of CS after operation code in the SLEEP command. However, when at least one SCK clock is inputted before the rising edge of CS after operation code in the SLEEP command, this SLEEP command is canceled.

After the SLEEP mode transition, SCK and SI inputs are logically ignored and SO changes to a Hi-Z state. In case all other pins are not fixed to VDD or VSS than CS, a through-current may flow.



Returning to an normal operation from the SLEEP mode is carried out after t_{REC} (Max 400 μ s) time from the falling edge of CS (see the figure below). It is possible to return CS to H level before t_{REC} time. However, it is prohibited to bring down CS to L level again during t_{REC} period.



■ BLOCK PROTECT

Writing protect block for WRITE command is configured by the value of BP0 and BP1 in the status register.

BP1	BP0	Protected Block
0	0	None
0	1	30000 _H to 3FFFF _H (upper 1/4)
1	0	20000 _H to 3FFFF _H (upper 1/2)
1	1	00000 _H to 3FFFF _H (all)

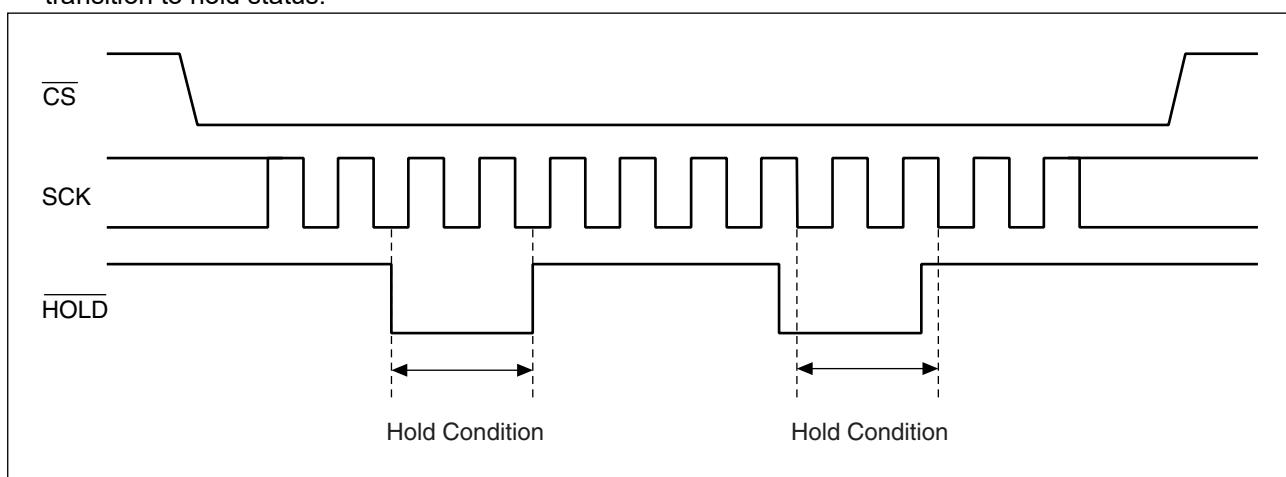
■ WRITING PROTECT

Writing operation of the WRITE command and the WRSR command are protected with the value of WEL, WPEN, WP as shown in the table.

WEL	WPEN	<u>WP</u>	Protected Blocks	Unprotected Blocks	Status Register
0	X	X	Protected	Protected	Protected
1	0	X	Protected	Unprotected	Unprotected
1	1	0	Protected	Unprotected	Protected
1	1	1	Protected	Unprotected	Unprotected

■ HOLD OPERATION

Hold status is retained without aborting a command if HOLD is "L" level while CS is "L" level. The timing for starting and ending hold status depends on the SCK to be "H" level or "L" level when a HOLD pin input is transited to the hold condition as shown in the diagram below. In case the HOLD pin transited to "L" level when SCK is "L" level, return the HOLD pin to "H" level at SCK being "L" level. In the same manner, in case the HOLD pin transited to "L" level when SCK is "H" level, return the HOLD pin to "H" level at SCK being "H" level. Arbitrary command operation is interrupted in hold status, SCK and SI inputs become do not care. And, SO becomes High-Z while reading command (RDSR, READ). If CS is rising during hold status, a command is aborted. In case the command is aborted before its recognition, WEL holds the value before transition to hold status.



■ ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Rating		Unit
		Min	Max	
Power supply voltage*	V _{DD}	- 0.5	+ 4.0	V
Input voltage*	V _{IN}	- 0.5	V _{DD} + 0.5 (≤ 4.0)	V
Output voltage*	V _{OUT}	- 0.5	V _{DD} + 0.5 (≤ 4.0)	V
Operation ambient temperature	T _A	- 40	+ 85	°C
Storage temperature	T _{STG}	- 55	+ 125	°C

*:These parameters are based on the condition that V_{SS} is 0 V.

WARNING: Semiconductor devices may be permanently damaged by application of stress (including, without limitation, voltage, current or temperature) in excess of absolute maximum ratings.
Do not exceed any of these ratings.

■ RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol	Value			Unit
		Min	Typ	Max	
Power supply voltage ¹	V _{DD}	1.7	3.3	3.6	V
Operation ambient temperature ²	T _A	- 40	—	+ 85	°C

*1: These parameters are based on the condition that V_{SS} is 0 V.

*2: Ambient temperature when only this device is working. Please consider it to be the almost same as the package surface temperature.

WARNING: The recommended operating conditions are required in order to ensure the normal operation of the semiconductor device. All of the device's electrical characteristics are warranted when the device is operated under these conditions.

Any use of semiconductor devices will be under their recommended operating condition.
Operation under any conditions other than these conditions may adversely affect reliability of device and could result in device failure.

No warranty is made with respect to any use, operating conditions or combinations not represented on this data sheet. If you are considering application under any conditions other than listed herein, please contact sales representatives beforehand.

■ ELECTRICAL CHARACTERISTICS

1. DC Characteristics

(within recommended operating conditions)

Parameter	Symbol	Condition	Value			Unit
			Min	Typ	Max	
Input leakage current* ¹	I _U	0 ≤ CS < V _{DD}	—	—	200	μA
		CS = V _{DD}	—	—	1	
		WP, HOLD, SCK SI = 0 V to V _{DD}	—	—	1	
Output leakage current* ²	I _O	SO = 0 V to V _{DD}	—	—	1	μA
Operating power supply current	I _{DD}	SCK = 1MHz	—	0.16	—	mA
		SCK = 33 MHz	—	1.6	2.0	
		SCK = 40 MHz	—	1.9	2.3	
Standby current	I _{SB}	SCK = SI = CS = V _{DD}	—	—	50	μA
Sleep current	I _{ZZ}	CS = V _{DD} All inputs V _{SS} or V _{DD}	—	—	10	μA
Input high voltage	V _{IH}	V _{DD} = 1.7 V to 3.6 V	V _{DD} × 0.7	—	V _{DD} + 0.5	V
Input low voltage	V _{IL}	V _{DD} = 1.7 V to 3.6 V	– 0.5	—	V _{DD} × 0.3	V
Output high voltage	V _{OH}	I _{OH} = – 2 mA	V _{DD} – 0.5	—	—	V
Output low voltage	V _{OL}	I _{OL} = 2 mA	—	—	0.4	V
Pull up resistance for CS	R _P	—	18	33	80	kΩ

*1 : Applicable pin : CS, WP, HOLD, SCK, SI

*2 : Applicable pin : SO

2. AC Characteristics

Parameter	Symbol	Value				Unit	
		$V_{DD} = 1.7 \text{ V to } 2.7 \text{ V}$		$V_{DD} = 2.7 \text{ V to } 3.6 \text{ V}$			
		Min	Max	Min	Max		
SCK clock frequency	f_{CK}	0	33	0	40	MHz	
Clock high time	t_{CH}	13	—	11	—	ns	
Clock low time	t_{CL}	13	—	11	—	ns	
Chip select set up time	t_{CSU}	10	—	10	—	ns	
Chip select hold time	t_{CSH}	10	—	10	—	ns	
Output disable time	t_{OD}	—	12	-	12	ns	
Output data valid time	t_{ODV}	—	13	-	9	ns	
Output hold time	t_{OH}	0	—	0	—	ns	
Deselect time	t_D	40	—	40	—	ns	
Data in rising time	t_R	—	50	-	50	ns	
Data falling time	t_F	—	50	-	50	ns	
Data set up time	t_{SU}	5	—	5	—	ns	
Data hold time	t_H	5	—	5	—	ns	
HOLD set uptime	t_{HS}	10	—	10	—	ns	
HOLD hold time	t_{HH}	10	—	10	—	ns	
HOLD output floating time	t_{HZ}	—	20	—	20	ns	
HOLD output active time	t_{LZ}	—	20	—	20	ns	
SLEEP recovery time	t_{REC}	—	400	—	400	μs	

AC Test Condition

Power supply voltage : 1.7 V to 3.6 V

Operation ambient temperature : -40°C to $+85^\circ\text{C}$

Input voltage magnitude : $V_{DD} \times 0.7 \leq V_{IH} \leq V_{DD}$

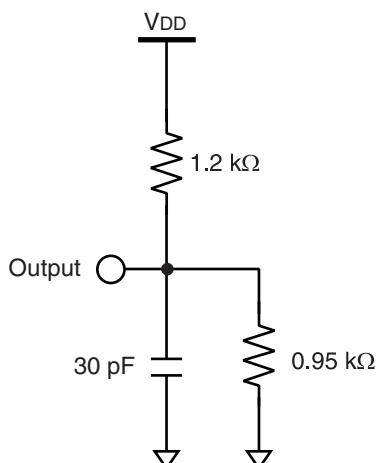
$0 \leq V_{IL} \leq V_{DD} \times 0.3$

Input rising time : 5 ns

Input falling time : 5 ns

Input judge level : $V_{DD}/2$

Output judge level : $V_{DD}/2$

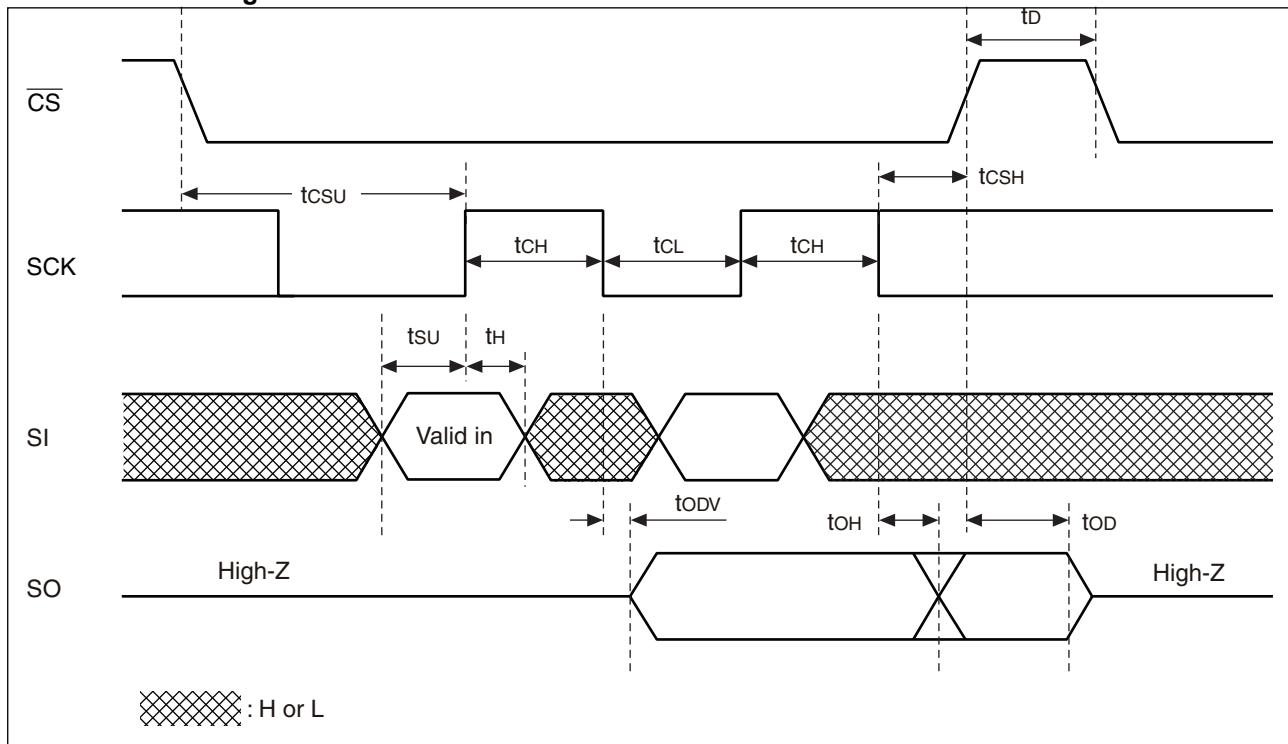
AC Load Equivalent Circuit**3. Pin Capacitance**

Parameter	Symbol	Condition	Value		Unit
			Min	Max	
Output capacitance	C_o	$V_{DD} = V_{IN} = V_{OUT} = 0\text{ V}$, $f = 1\text{ MHz}$, $T_A = +25\text{ }^\circ\text{C}$	—	8	pF
Input capacitance	C_i		—	6	pF

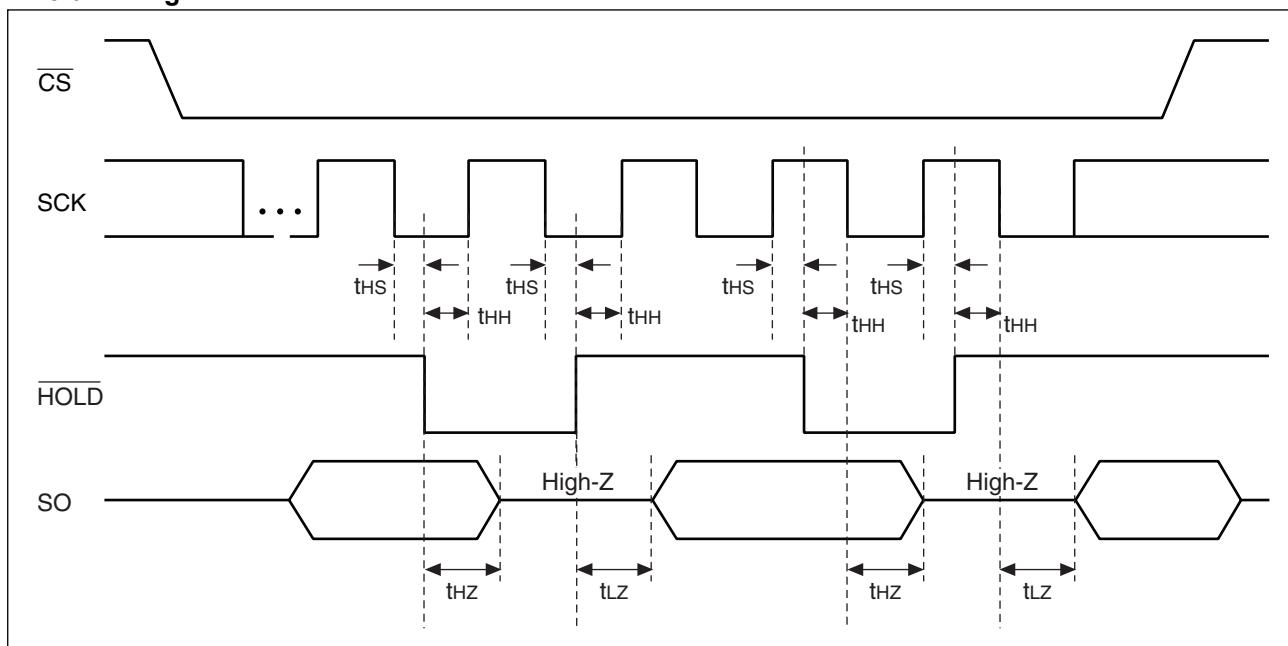
MB85RS2MTA

■ TIMING DIAGRAM

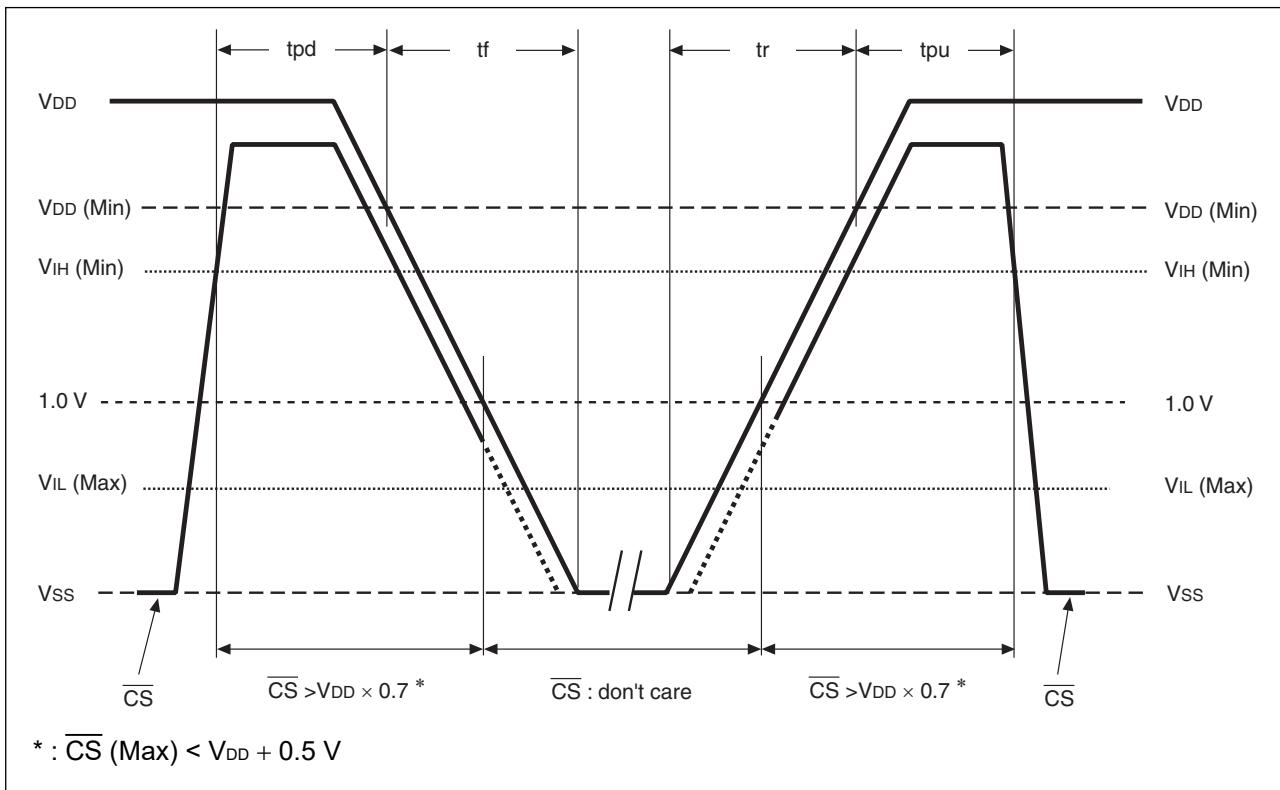
- Serial Data Timing



- Hold Timing



■ POWER ON/OFF SEQUENCE



Parameter	Symbol	Value		Unit	Parameters
		Min	Max		
\overline{CS} level hold time at power OFF	tpd	0	—	ns	$V_{DD} = 2.7V \text{ to } 3.6V$
		400	—		$V_{DD} = 1.7V \text{ to } 2.7V$
\overline{CS} level hold time at power ON	tpu	250	—	μs	
Power supply rising time	tr	0.05	—	ms/V	
Power supply falling time	tf	0.1	—	ms/V	

If the device does not operate within the specified conditions of read cycle, write cycle or power on/off sequence, memory data can not be guaranteed.

■ FeRAM CHARACTERISTICS

Parameter	Value		Unit	Remarks
	Min	Max		
Read/Write Endurance	10^{13}	—	Times/byte	Operation Ambient Temperature $T_A = + 85^\circ C$
Data Retention	10	—	Years	Operation Ambient Temperature $T_A = + 85^\circ C$
	95	—		Operation Ambient Temperature $T_A = + 55^\circ C$

*1 : Total number of reading and writing defines the minimum value of endurance, as an FeRAM memory operates with destructive readout mechanism.

*2: Minimum values define retention time of the first reading/writing data right after shipment, and these values are calculated by qualification results.

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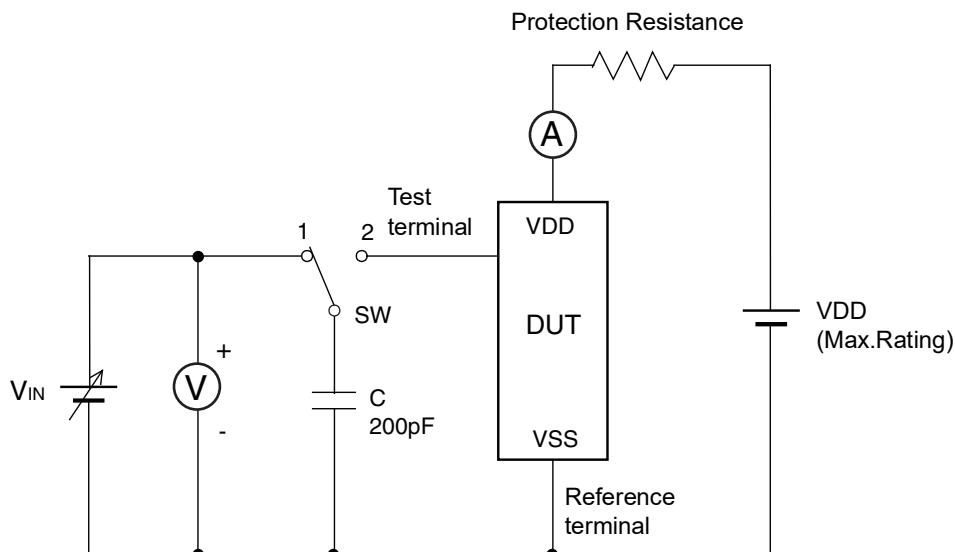
■ NOTE ON USE

We recommend programming of the device after reflow. Data written before reflow cannot be guaranteed.

■ ESD AND LATCH-UP

Test	DUT	Value
ESD HBM (Human Body Model) JESD22-A114 compliant	MB85RS2MTAPNF-G-BDE1 MB85RS2MTAPNF-G-BDERE1	$\geq 2000\text{ V} $
ESD CDM (Charged Device Model) JESD22-C101 compliant	MB85RS2MTAPNF-G-AWE2 MB85RS2MTAPNF-G-AWERE2	$\geq 1000\text{ V} $
Latch-Up (C-V Method) Proprietary method	MB85RS2MTAPF-G-BCE1 MB85RS2MTAPF-G-BCERE1	$\geq 200\text{ V} $

- C-V method of Latch-Up Resistance Test



Note : Charge voltage alternately switching 1 and 2 approximately 2 sec interval. This switching process is considered as one cycle. Repeat this process 5 times. However, if the latch-up condition occurs before completing 5times, this test must be stopped immediately.

■ MB85RS2MTAPNF/MB85RS2MTAPF (8-pin plastic SOP) REFLOW CONDITIONS AND FLOOR LIFE

[JEDEC MSL] : Moisture Sensitivity Level 3 (IPC/JEDEC J-STD-020E)

■ CURRENT STATUS ON CONTAINED RESTRICTED SUBSTANCES

This product complies with the regulations of REACH Regulations, EU RoHS Directive and China RoHS.

■ ORDERING INFORMATION

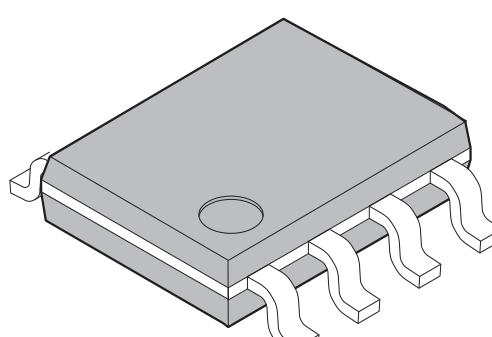
Part number	Package	Shipping form	Minimum shipping quantity
MB85RS2MTAPNF-G-BDE1	8-pin plastic SOP (150mil)	Tube	— *
MB85RS2MTAPNF-G-BDERE1	8-pin plastic SOP (150mil)	Embossed Carrier tape	1500
MB85RS2MTAPNF-G-AWE2	8-pin plastic SOP (150mil)	Tube	— *
MB85RS2MTAPNF-G-AWERE2	8-pin plastic SOP (150mil)	Embossed Carrier tape	1500
MB85RS2MTAPF-G-BCE1	8-pin plastic SOP (208mil)	Tube	— *
MB85RS2MTAPF-G-BCERE1	8-pin plastic SOP (208mil)	Embossed Carrier tape	500

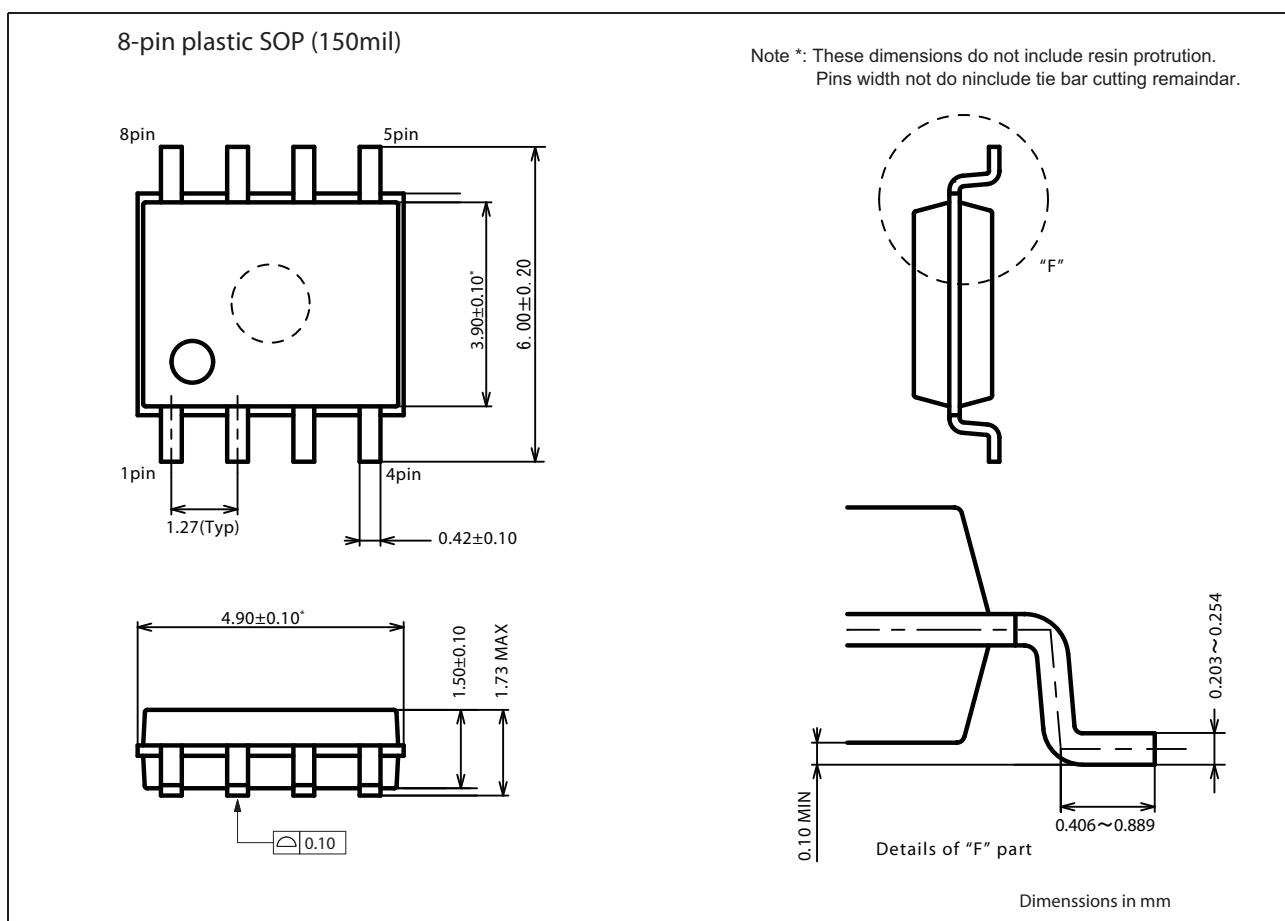
* : Please contact our sales office about minimum shipping quantity.

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■ PACKAGE DIMENSION

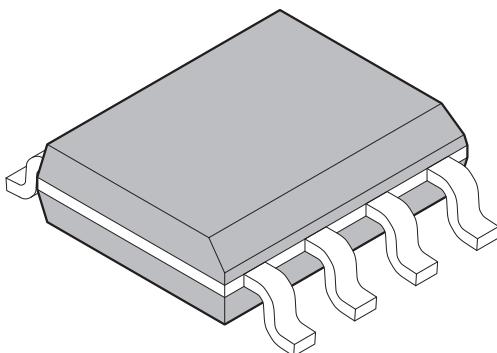
(1) MB85RS2MTAPNF-G-BDE1/MB85RS2MTAPNF-G-BDERE1

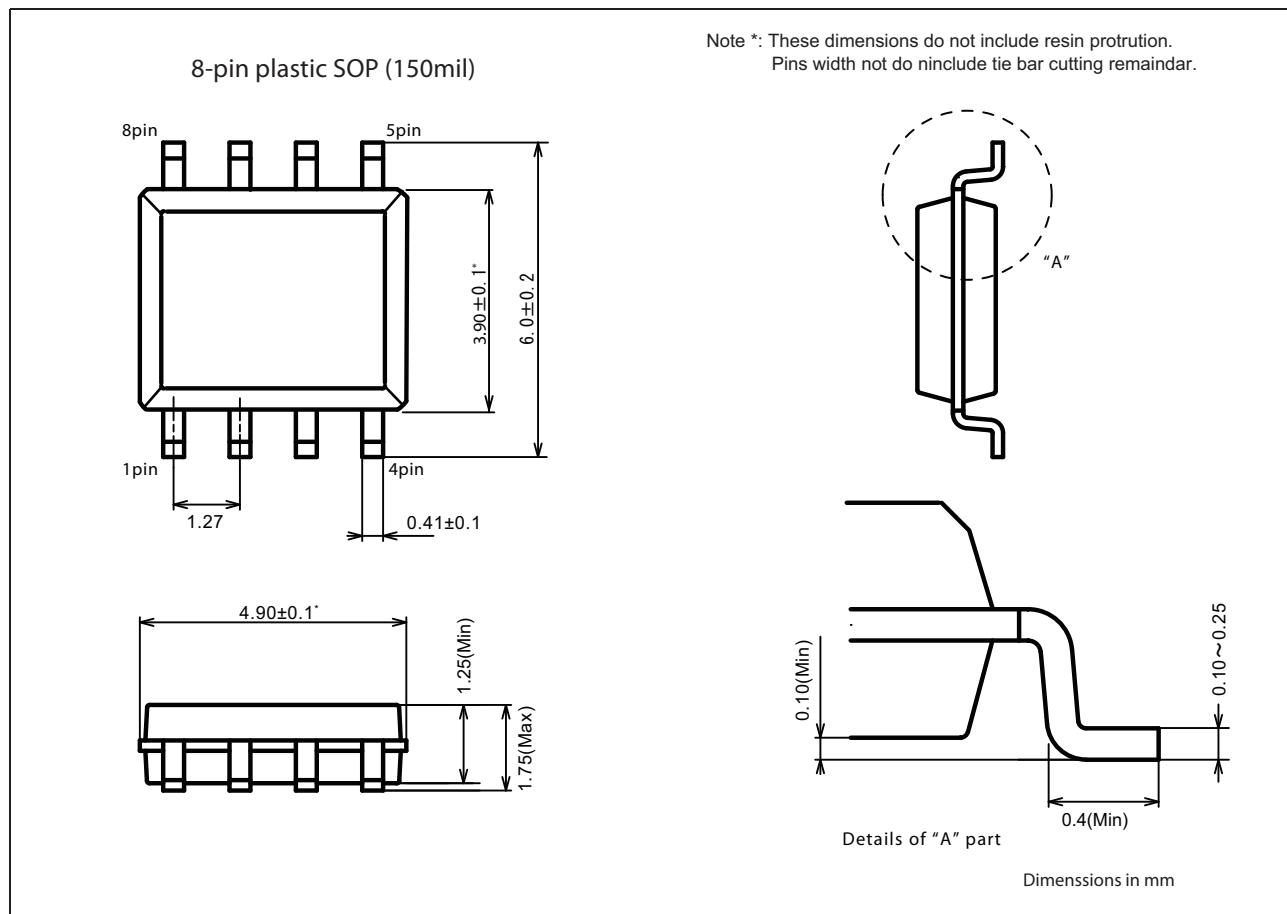
 MB85RS2MTAPNF-G-BDE1/MB85RS2MTAPNF-G-BDERE1	Lead pitch Package width × package length Lead shape Sealing method Mounting height	1.27 mm 3.9 mm × 4.89 mm Gullwing Plastic mold 1.73 mm MAX



(continued)

(2)MB85RS2MTAPNF-G-AWE2/MB85RS2MTAPNF-G-AWERE2

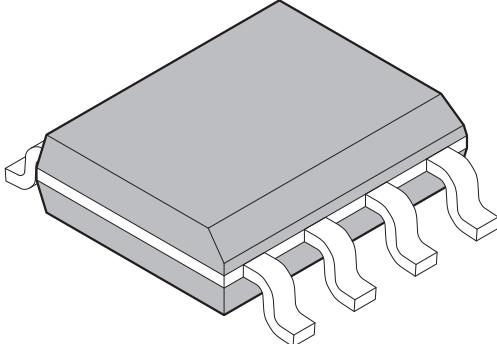
 MB85RS2MTAPNF-G-AWE2/MB85RS2MTAPNF-G-AWERE2							
Lead pitch	1.27mm						
Package width × package length	3.9mm × 4.90mm						
Lead shape	Gullwing						
Sealing method	Plastic mold						
Mounting height	1.75mm MAX						

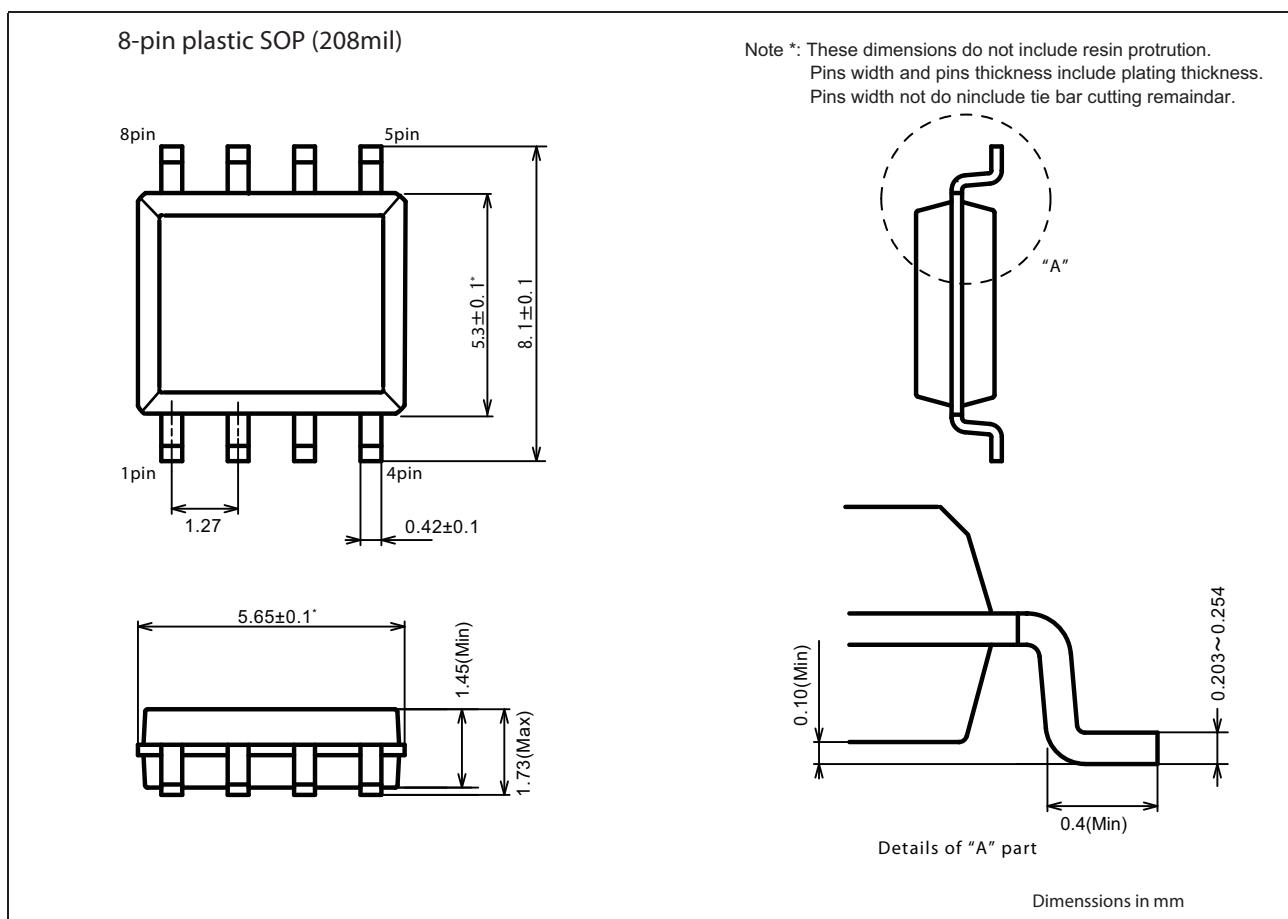


MB85RS2MTA

(continued)

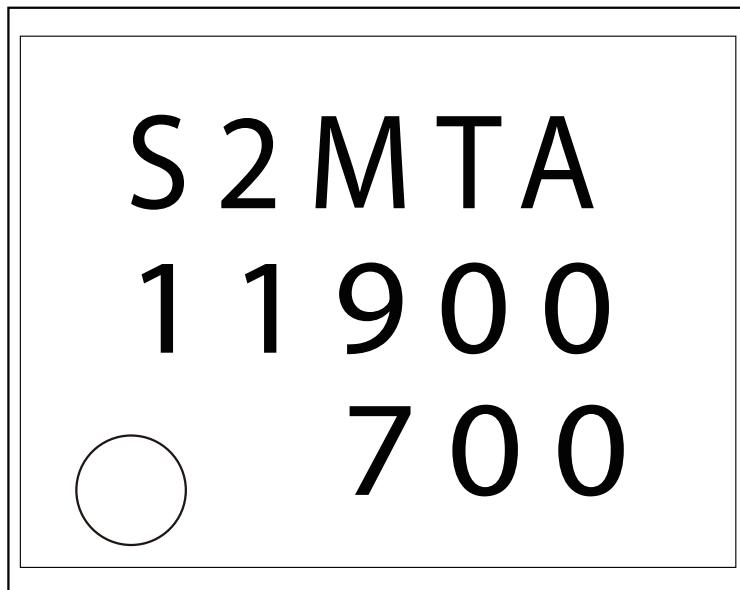
(3) MB85RS2MTAPF-G-BCE1/MB85RS2MTAPF-G-BCERE1

 MB85RS2MTAPF-G-BCE1/MB85RS2MTAPF-G-BCERE1		
	Lead pitch	1.27 mm
	Package width × package length	5.30 mm × 5.65 mm
	Lead shape	Gullwing
	Sealing method	Plastic mold
	Mounting height	1.73 mm MAX



■ MARKING

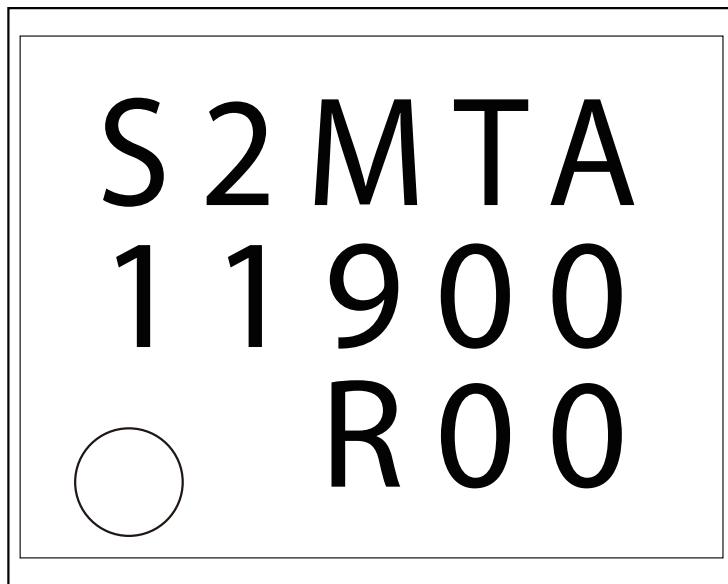
[MB85RS2MTAPNF-G-BDE1]
[MB85RS2MTAPNF-G-BDERE1]



[8-pin plastic SOP, 150mil]

S2MTA: Product Name
11900: 1 (CS code) + 1900(Year and Week code)
700: Trace code

[MB85RS2MTAPNF-G-AWE2]
[MB85RS2MTAPNF-G-AWERE2]

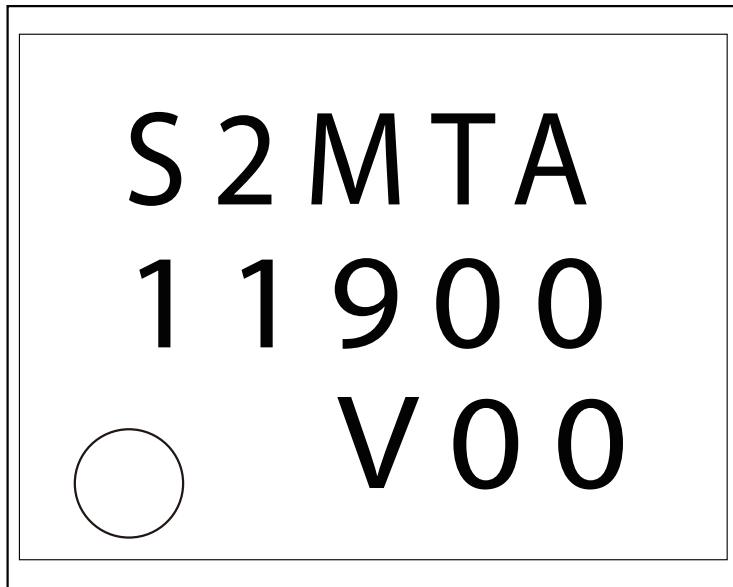


[8-pin plastic SOP, 150mil]

S2MTA: Product Name
11900: 1 (CS code) + 1900(Year and Week code)
R00: Trace code

MB85RS2MTA

[MB85RS2MTAPF-G-BCE1]
[MB85RS2MTAPF-G-BCERE1]



[8-pin plastic SOP, 208mil]

S2MTA: Product Name

11900: 1 (CS code) + 1900(Year and Week code)

V00: Trace code

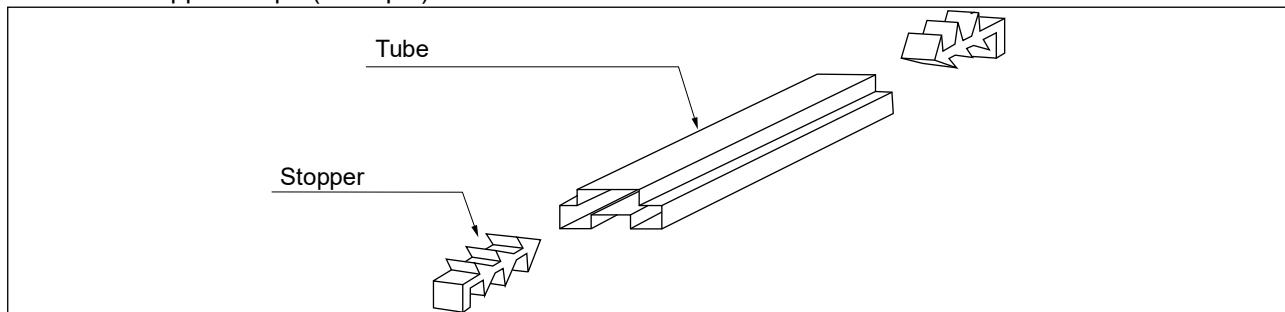
■ PACKING INFORMATION

(1) MB85RS2MTAPNF-G-BDE1/MB85RS2MTAPNF-G-BDERE1
 (8-pin plastic SOP, 150mil)

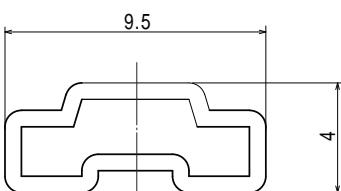
1. Tube (MB85RS2MTAPNF-G-BDE1)

1.1 Tube Dimensions

- Tube/stopper shape (example)



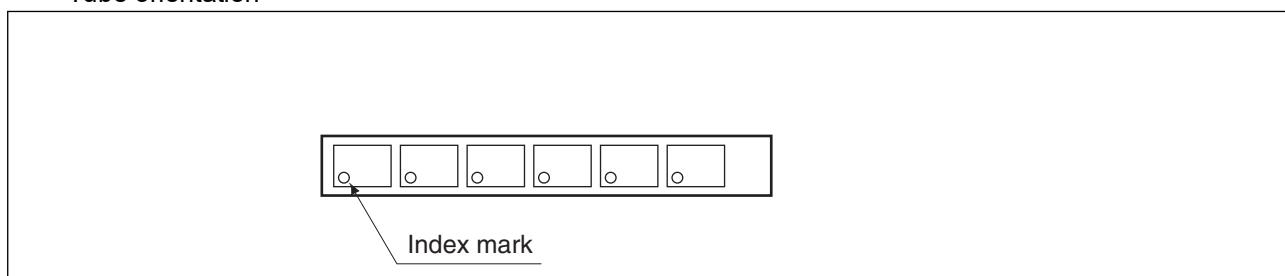
- Tube cross-sections and Maximum quantity

Package form	Maximum quantity		
	ICs/tube(500mm)	ICs/inner box	ICs/outer box
	85	4,250	17,000

No heat resistance.
 Package should not be baked by using tape and reel.

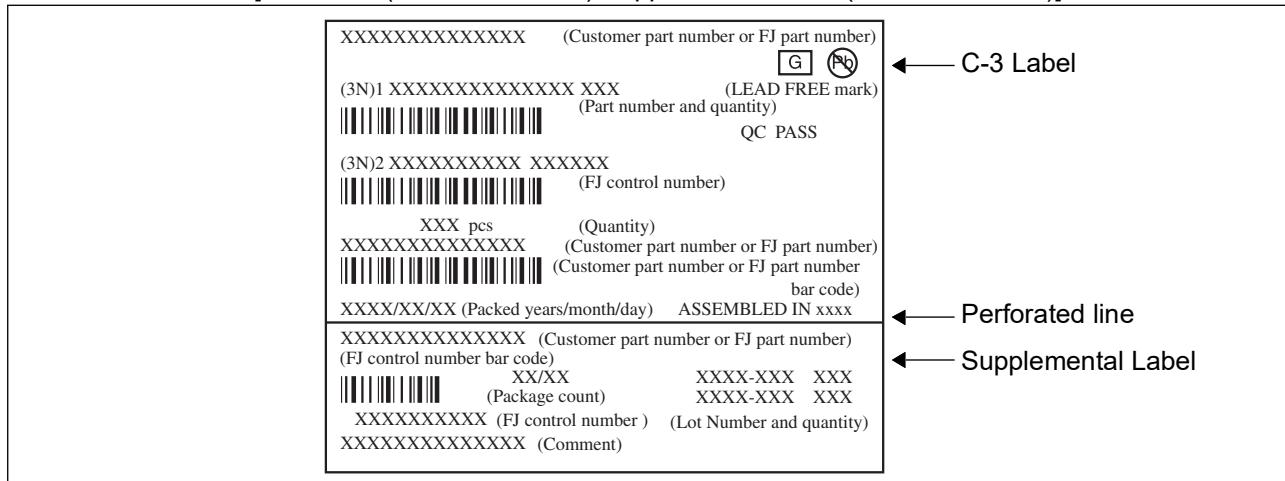
(Dimensions in mm)

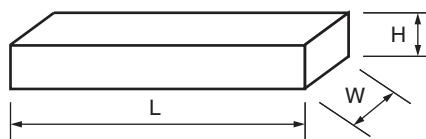
- Tube orientation



1.2 Product label indicators (example)

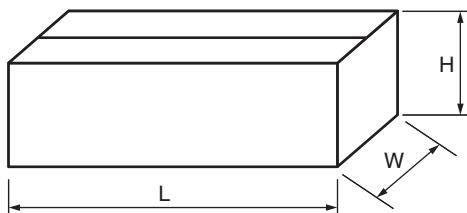
Label I: Label on Inner box/Moisture Barrier Bag/ (It sticks it on the reel for the emboss taping)
[C-3 Label (50mm × 100mm) Supplemental Label (20mm × 100mm)]



1.3 Dimensions for Containers**(1) Dimensions for inner box**

L	W	H
540	125	75

(Dimensions in mm)

(2) Dimensions for outer box

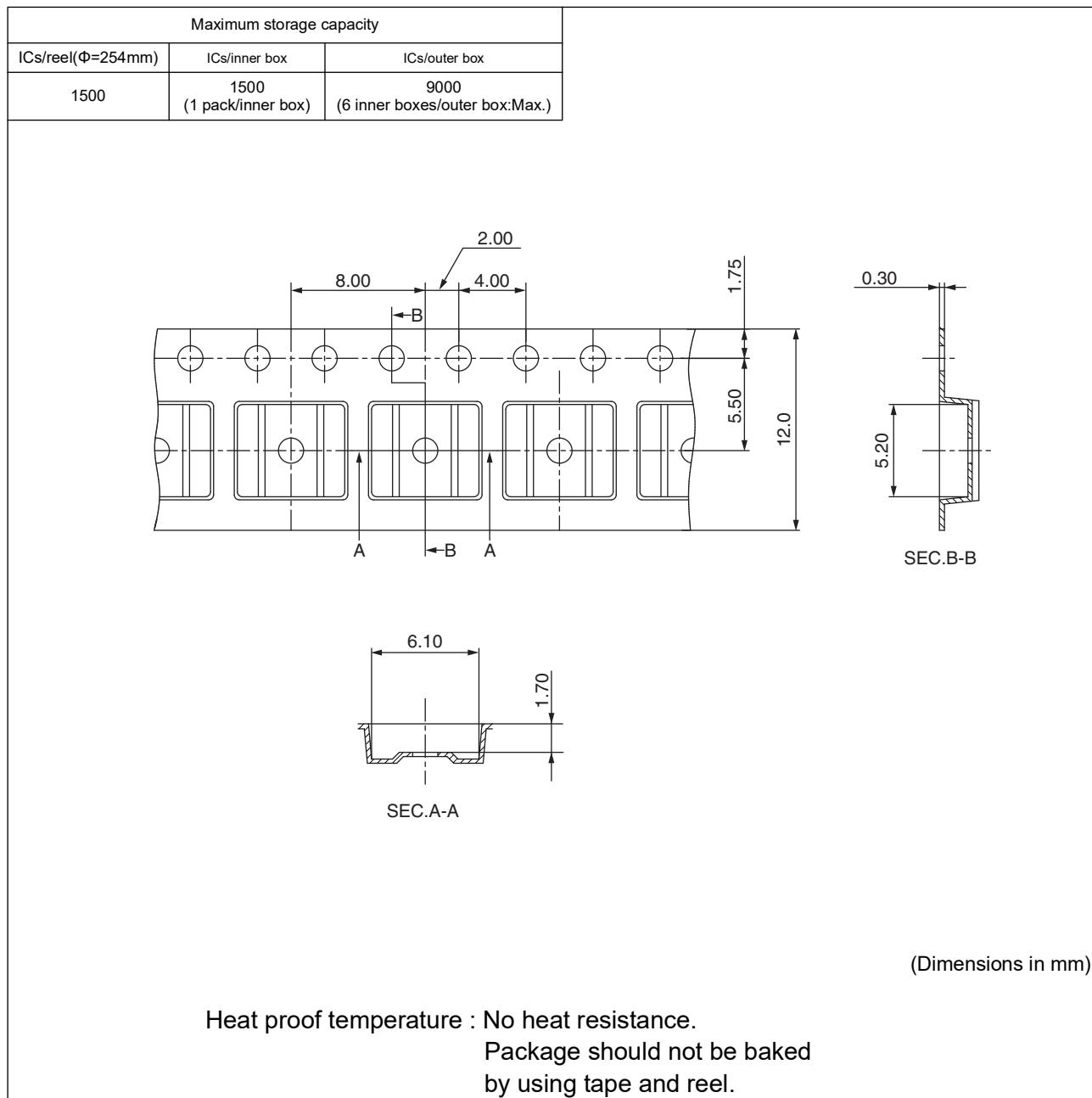
L	W	H
549	277	180

(Dimensions in mm)

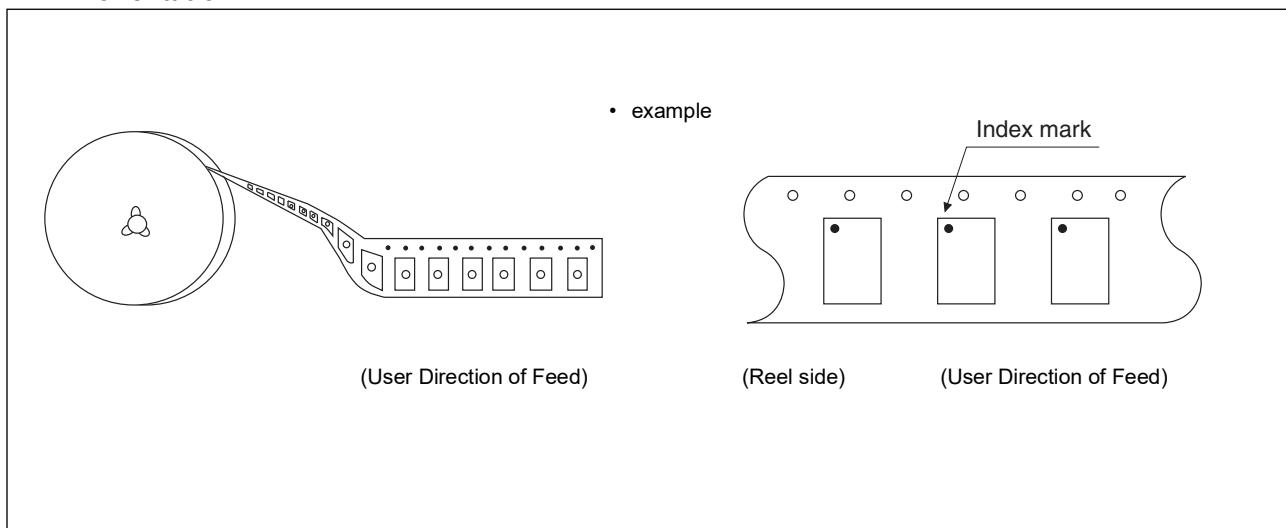
MB85RS2MTA

2. Emboss Tape (MB85RS2MTAPNF-G-BDERE1)

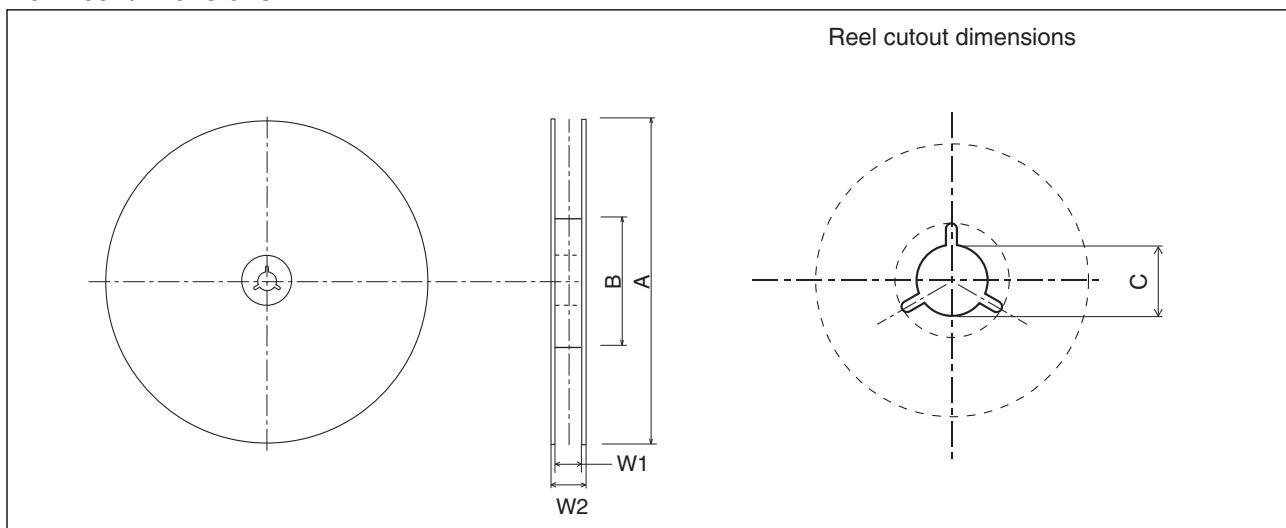
2.1 Tape Dimensions (not drawn to scale)(8-pin plastic SOP, 150mil)



2.2 IC orientation



2.3 Reel dimensions

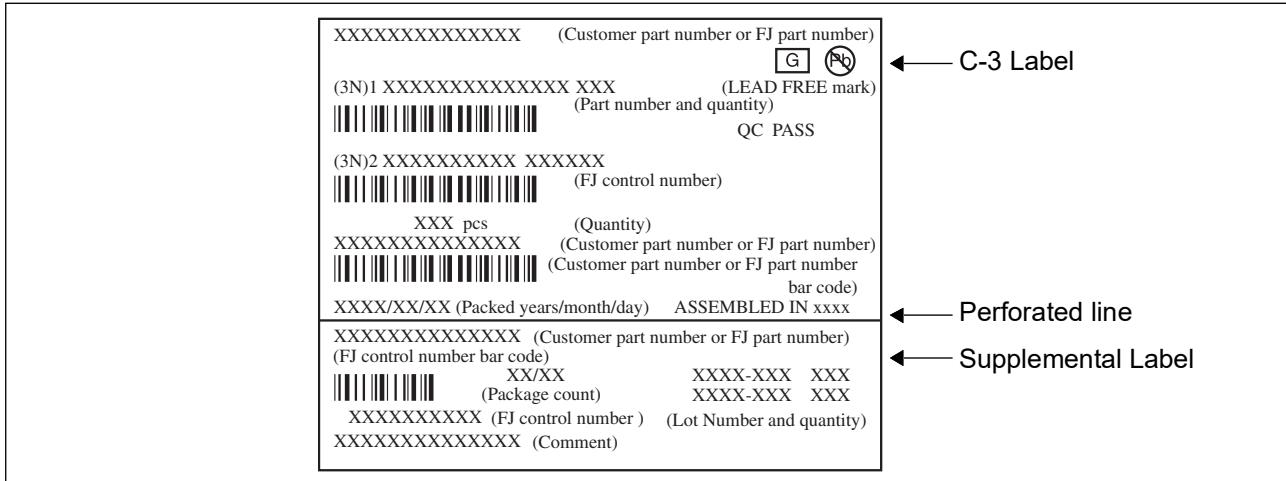


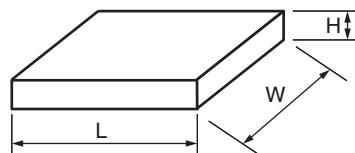
Dimensions in mm

A	B	C	W1	W2
254	100	13	13.5	17.5

2.4 Product label indicators (example)

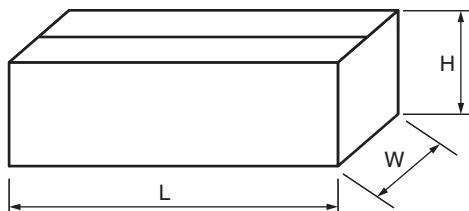
Label I: Label on Inner box/Moisture Barrier Bag/ (It sticks it on the reel for the emboss taping)
[C-3 Label (50mm × 100mm) Supplemental Label (20mm × 100mm)]



2.5 Dimensions for Containers**(1) Dimensions for inner box**

L	W	H
265	262	51

(Dimensions in mm)

(2) Dimensions for outer box

L	W	H
549	277	180

(Dimensions in mm)

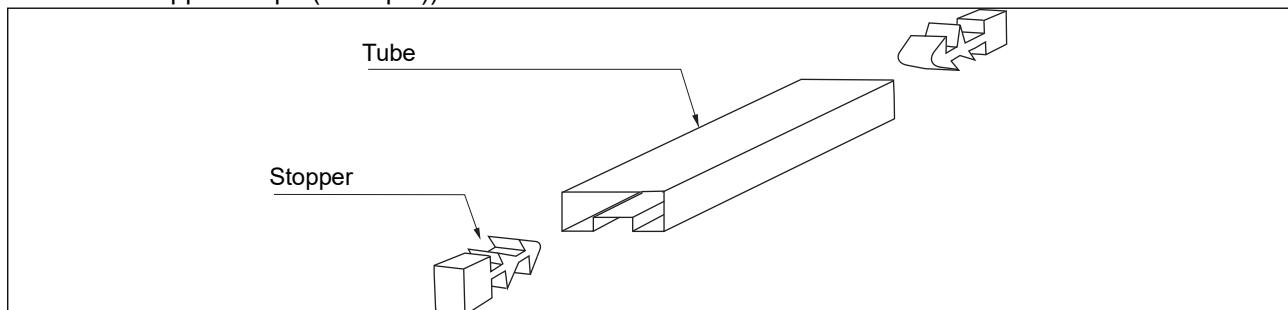
MB85RS2MTA

(2)MB85RS2MTAPNF-G-AWE2/MB85RS2MTAPNF-G-AWERE2
(8-pin plastic SOP, 150mil)

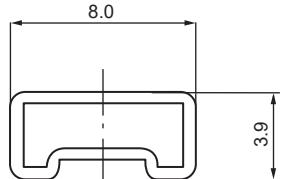
1. Tube (MB85RS2MTAPNF-G-AWE2)

1.1 Tube Dimensions

- Tube/stopper shape (example))



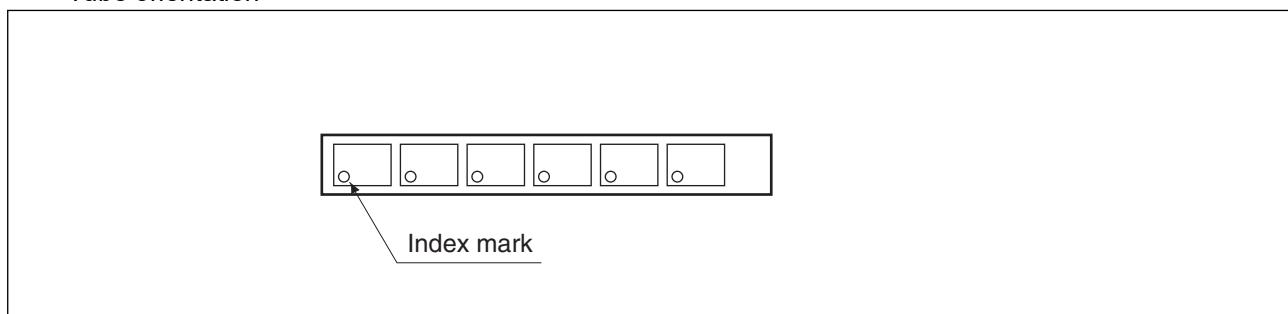
- Tube cross-sections and Maximum quantity

Package form	Maximum quantity		
	ICs/tube(509mm)	ICs/inner box	ICs/outer box
	85	4,250	25,500

No heat resistance.
Package should not be baked by using tape and reel.

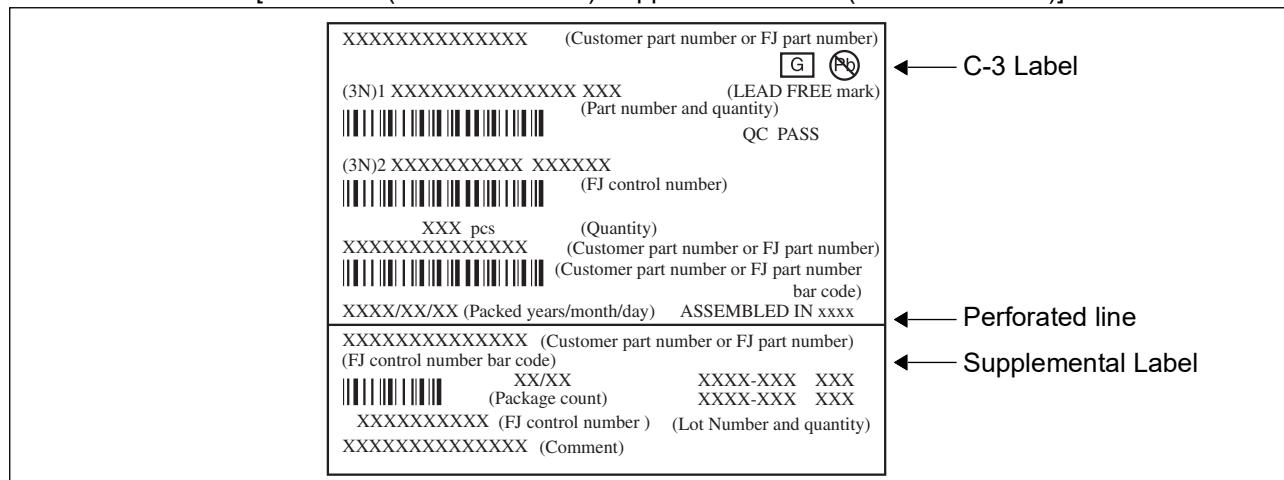
(Dimensions in mm)

- Tube orientation



1.2 Product label indicators (example)

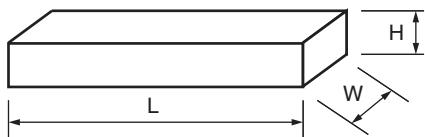
Label I: Label on Inner box/Moisture Barrier Bag/ (It sticks it on the reel for the emboss taping)
[C-3 Label (50mm × 100mm) Supplemental Label (20mm × 100mm)]



MB85RS2MTA

1.3 Dimensions for Containers

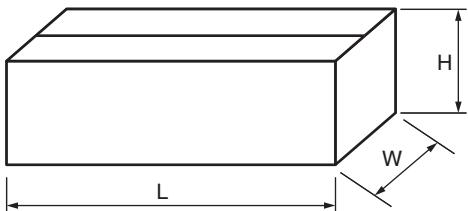
(1) Dimensions for inner box



L	W	H
540	125	81

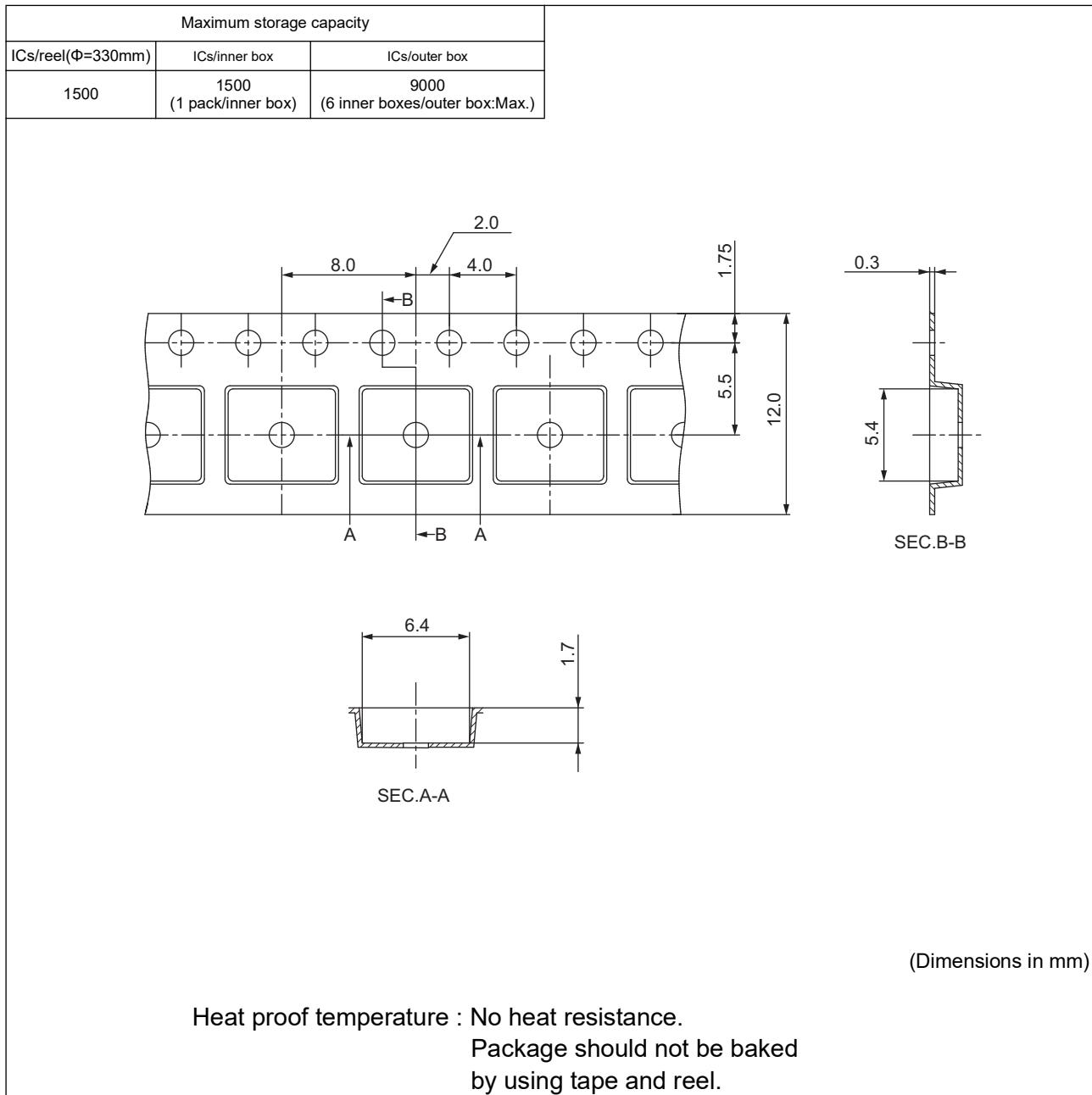
(Dimensions in mm)

(2) Dimensions for outer box



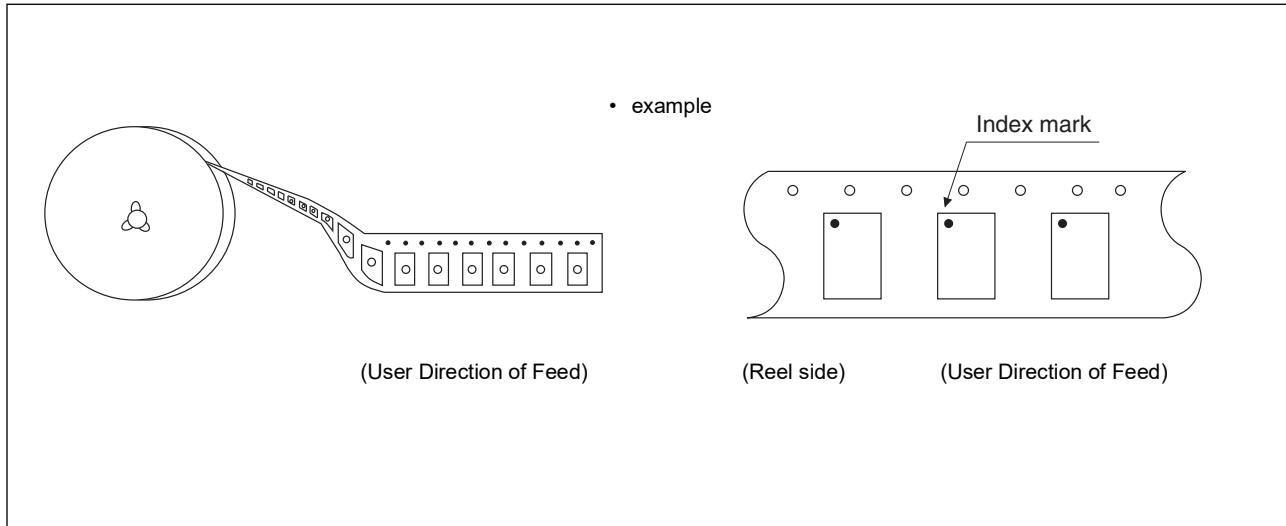
L	W	H
567	272	269

(Dimensions in mm)

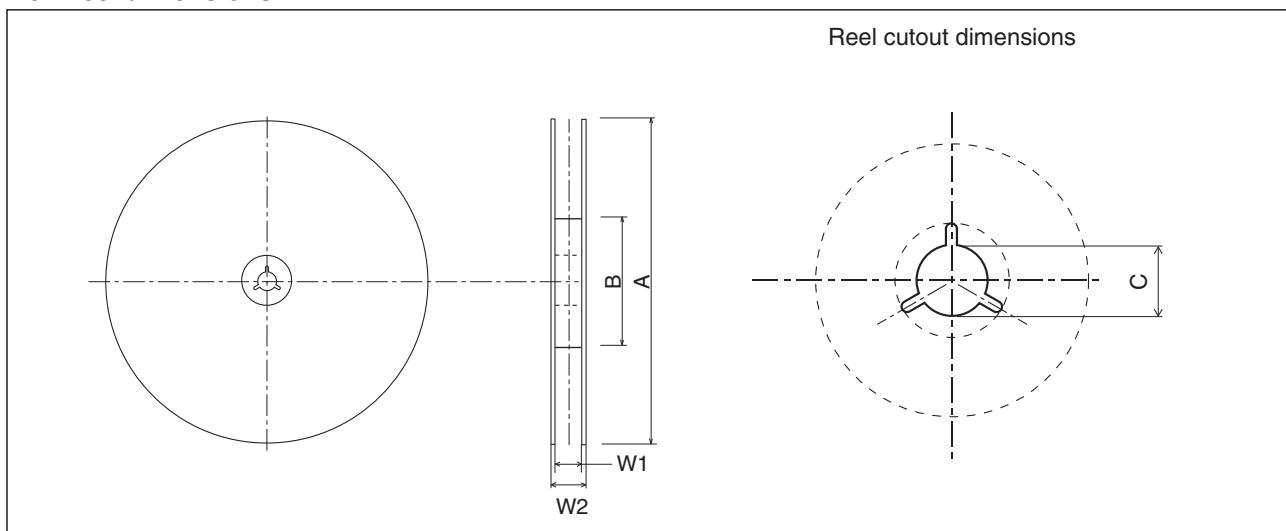
2. Emboss Tape (MB85RS2MTAPNF-G-AWERE2)**2.1 Tape Dimensions (not drawn to scale)(8-pin plastic SOP, 150mil)**

MB85RS2MTA

2.2 IC orientation

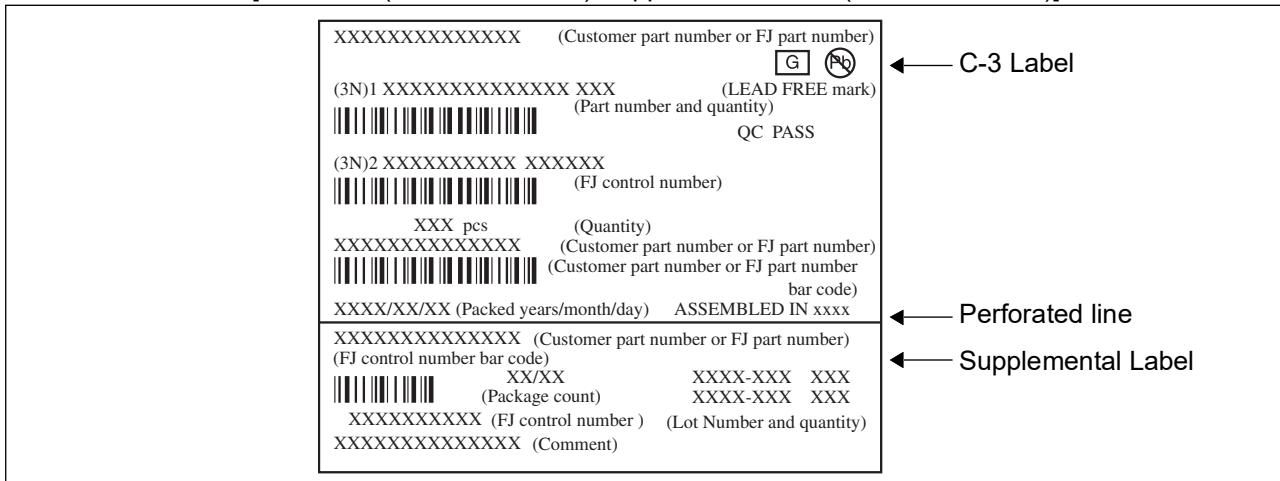


2.3 Reel dimensions



2.4 Product label indicators (example)

Label I: Label on Inner box/Moisture Barrier Bag/ (It sticks it on the reel for the emboss taping)
[C-3 Label (50mm × 100mm) Supplemental Label (20mm × 100mm)]



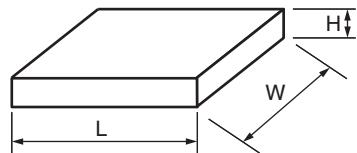
Label II: Moisture Barrier Bag (It sticks it on the Aluminum laminated bag)
[MSL Label (100mm × 70mm)]



MB85RS2MTA

2.5 Dimensions for Containers

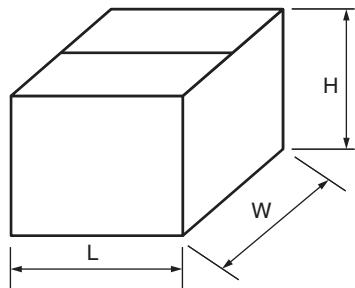
(1) Dimensions for inner box



L	W	H
350	335	35

(Dimensions in mm)

(2) Dimensions for outer box



L	W	H
384	368	225

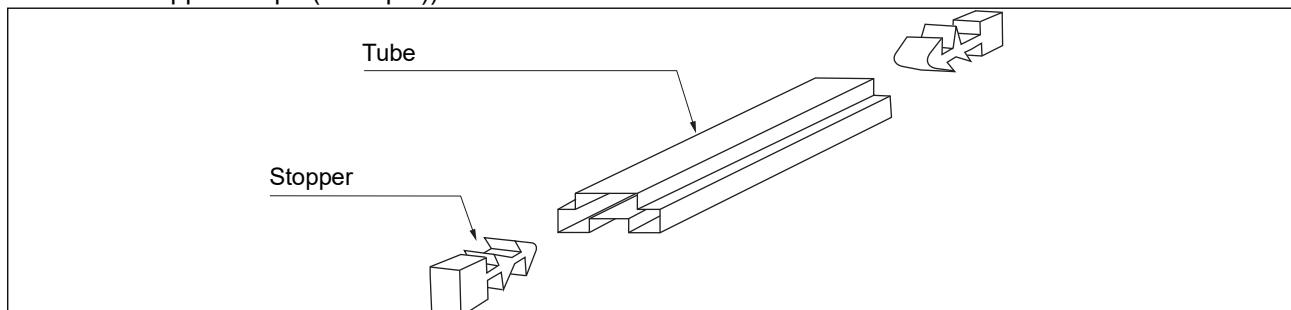
(Dimensions in mm)

(3)MB85RS2MTAPF-G-BCE1/MB85RS2MTAPF-G-BCERE1
(8-pin plastic SOP, 208mil)

1. Tube (MB85RS2MTAPF-G-BCE1)

1.1 Tube Dimensions

- Tube/stopper shape (example))



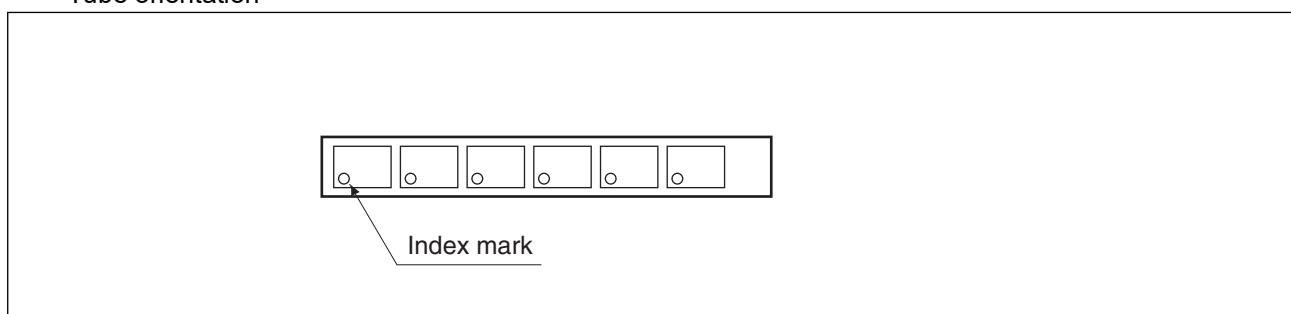
- Tube cross-sections and Maximum quantity

Package form	Maximum quantity		
	ICs/tube(509mm)	ICs/inner box	ICs/outer box
	80	4,000	16,000

No heat resistance.
Package should not be baked by using tape and reel.

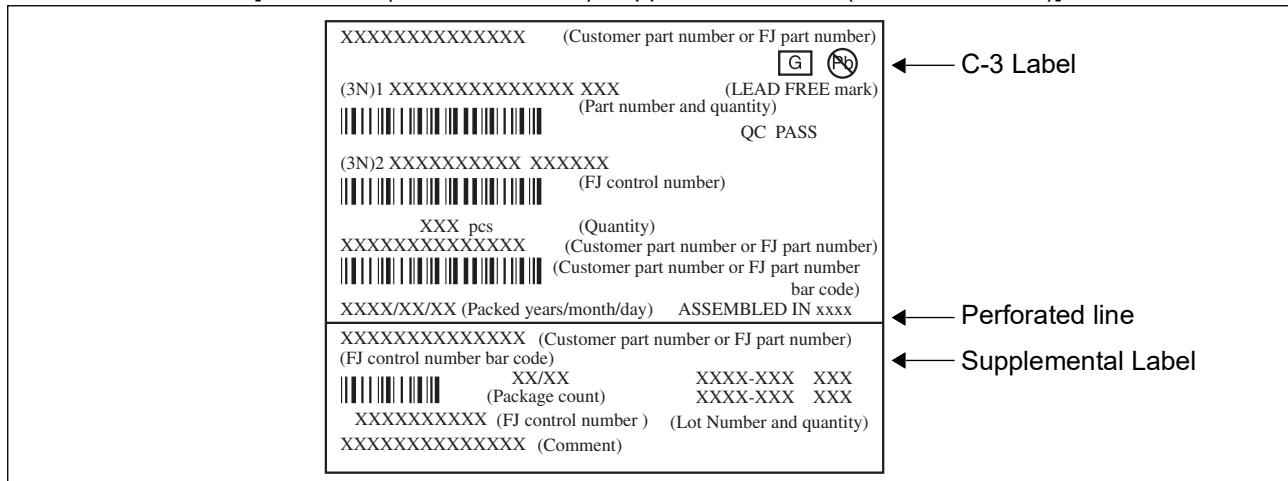
(Dimensions in mm)

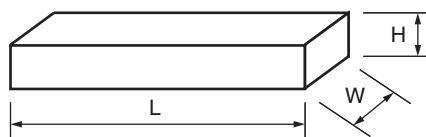
- Tube orientation



1.2 Product label indicators (example)

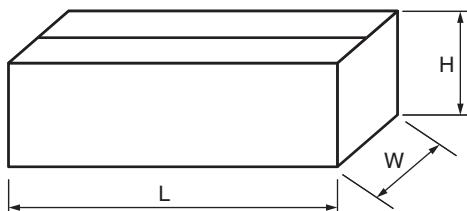
Label I: Label on Inner box/Moisture Barrier Bag/ (It sticks it on the reel for the emboss taping)
[C-3 Label (50mm × 100mm) Supplemental Label (20mm × 100mm)]



1.3 Dimensions for Containers**(1) Dimensions for inner box**

L	W	H
533	124	73

(Dimensions in mm)

(2) Dimensions for outer box

L	W	H
549	277	180

(Dimensions in mm)

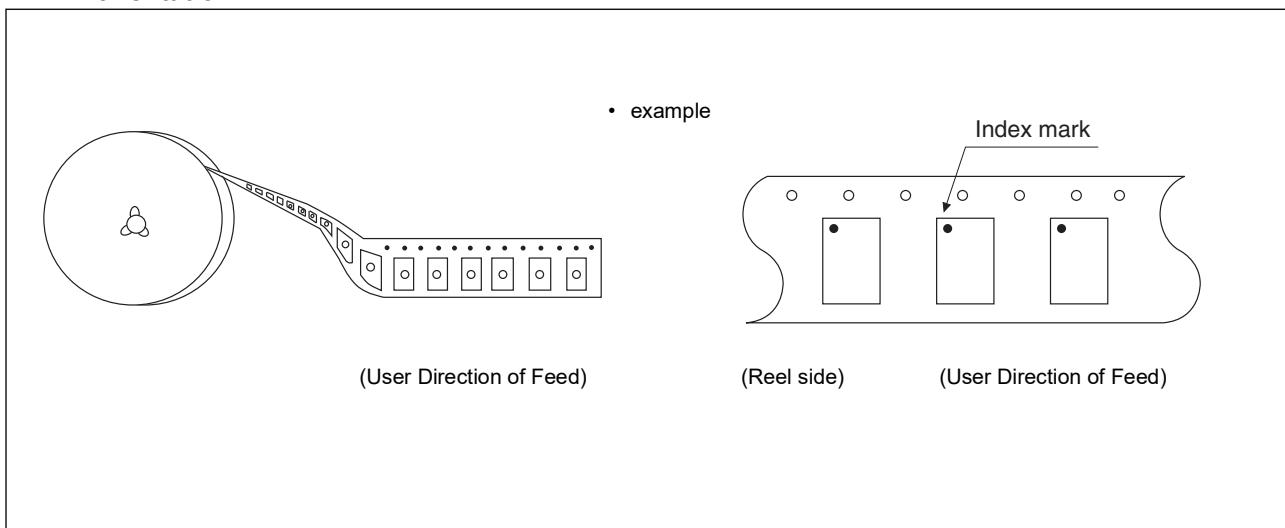
MB85RS2MTA

2. Emboss Tape (MB85RS2MTAPF-G-BCERE1)

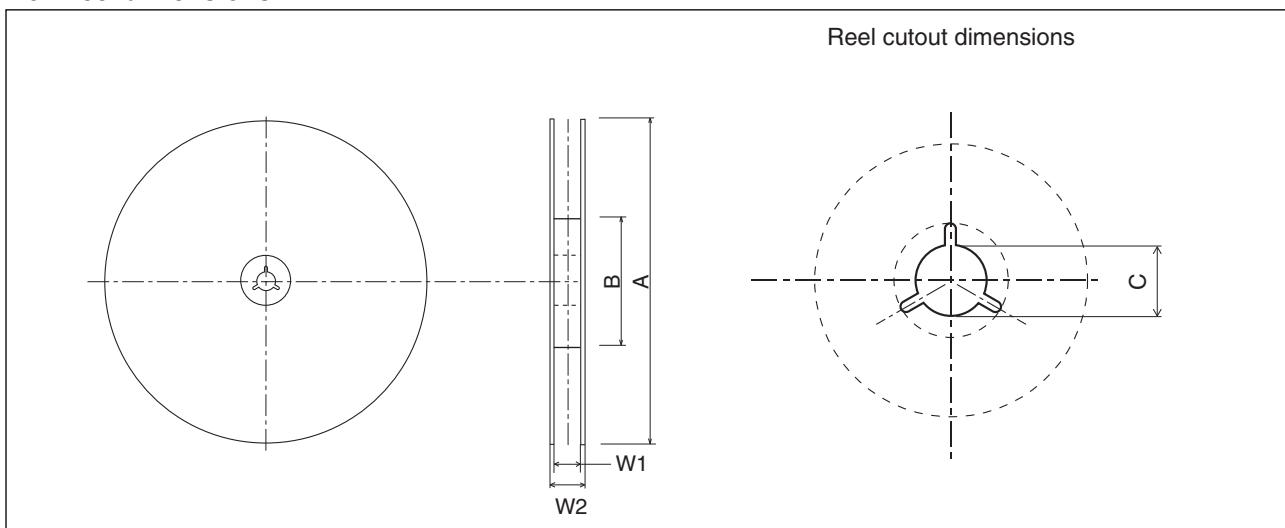
2.1 Tape Dimensions (not drawn to scale)(8-pin plastic SOP, 208mil)

Maximum storage capacity		
ICs/reel($\Phi=254\text{mm}$)	ICs/inner box	ICs/outer box
500	500 (1 pack/inner box)	3000 (6 inner boxes/outer box:Max.)
 SEC.A-A SEC.B-B		
(Dimensions in mm)		
<p>Heat proof temperature : No heat resistance. Package should not be baked by using tape and reel.</p>		

2.2 IC orientation



2.3 Reel dimensions

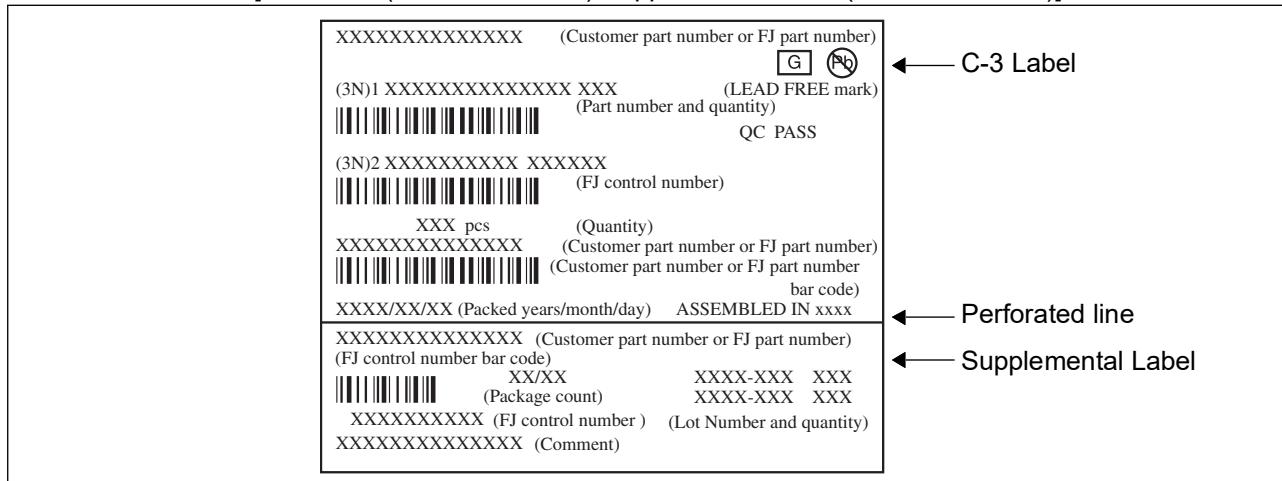


Dimensions in mm

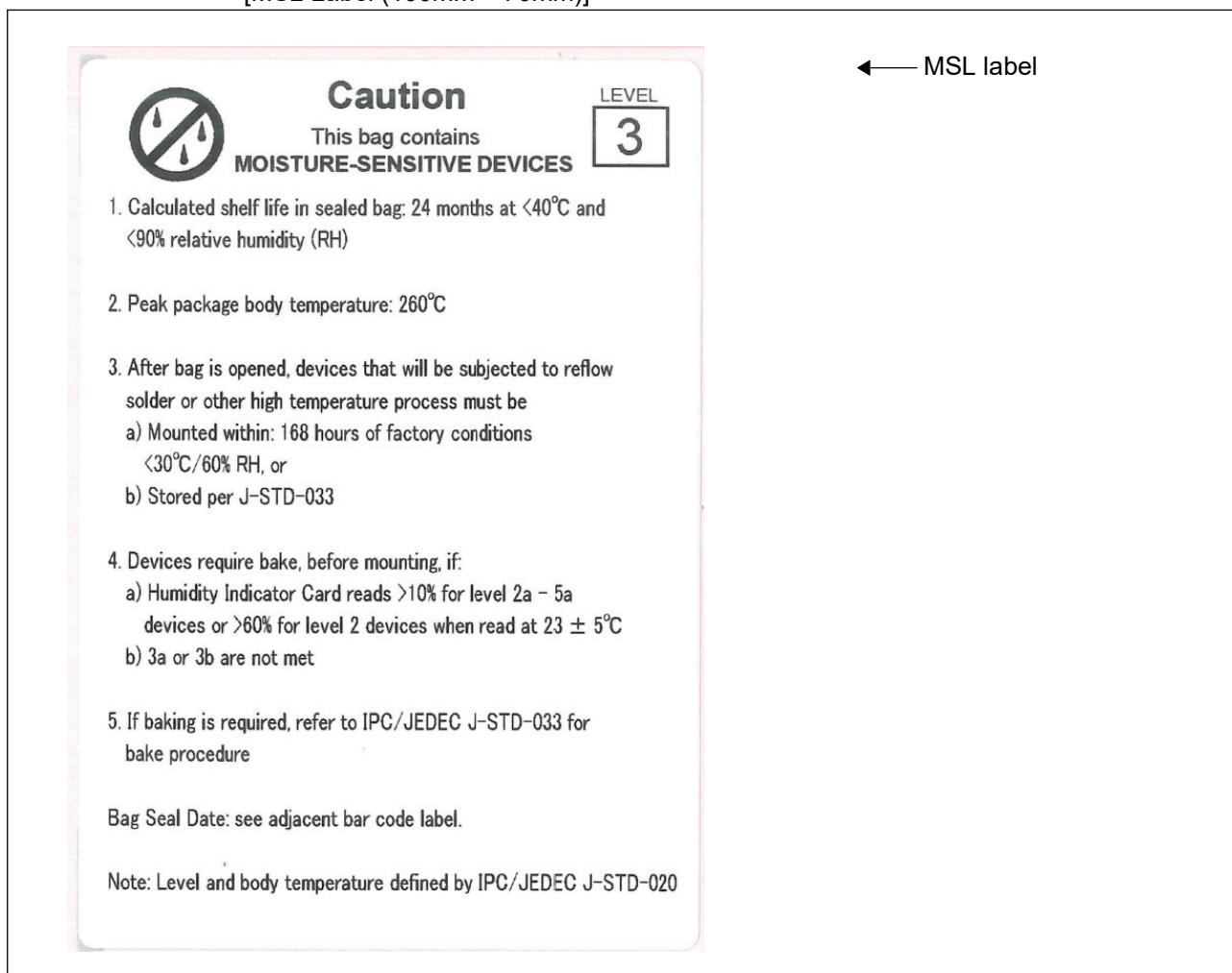
A	B	C	W1	W2
254	100	13	17.5	21.5

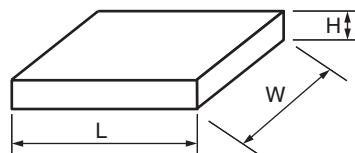
2.4 Product label indicators (example)

Label I: Label on Inner box/Moisture Barrier Bag/ (It sticks it on the reel for the emboss taping)
[C-3 Label (50mm × 100mm) Supplemental Label (20mm × 100mm)]



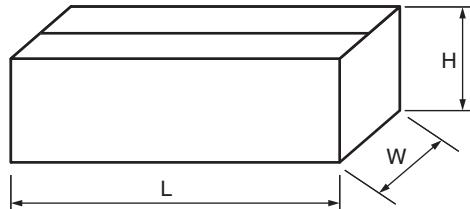
Label II: Moisture Barrier Bag (It sticks it on the Aluminum laminated bag)
[MSL Label (100mm × 70mm)]



2.5 Dimensions for Containers**(1) Dimensions for inner box**

L	W	H
265	262	51

(Dimensions in mm)

(2) Dimensions for outer box

L	W	H
549	277	180

(Dimensions in mm)

■ MAJOR CHANGES IN THIS EDITION

Changes on pages are indicated by vertical lines drawn on the left side of that pages.

Page	Section	Change Results
—	Overall	Following technical word is revised to more commonly used one. FRAM to FeRAM

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